

# LOG114 Single-Supply, High-Speed, Precision Logarithmic Amplifier

## 1 Features

- Advantages:
  - Tiny for high density systems
  - Precision on one supply
  - Fast over eight decades
  - Fully-tested function
- Two scaling amplifiers
- Wide input dynamic range: eight decades, 100pA to 10mA
- 2.5V reference
- Stable over temperature
- Low quiescent current: 10mA
- Dual or single supply:  $\pm 5V$ , 5V
- Package: Small QFN-16 (4mm  $\times$  4mm)
- Specified temperature range:  $-5^{\circ}C$  to  $75^{\circ}C$

## 2 Applications

- Onet erbium-doped fiber optic amplifiers (EDFA)
- Laser optical density measurement
- Photodiode signal compression amplifiers
- Log, log-ratio function
- Analog signal compression in front of analog-to-digital converters (ADC)
- Absorbance measurement

## 3 Description

The LOG114 is specifically designed for measuring low-level and wide dynamic range currents in communications, lasers, medical, and industrial systems. The device computes the logarithm or log-ratio of an input current or voltage relative to a reference current or voltage (logarithmic transimpedance amplifier).

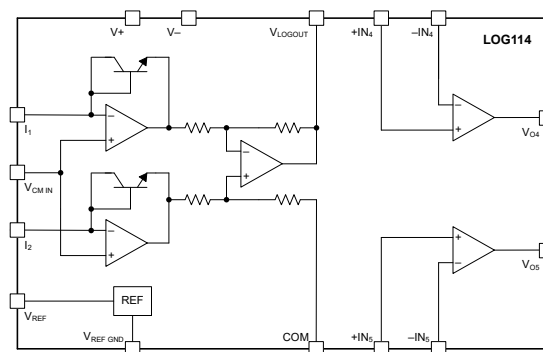
High precision is ensured over a wide dynamic range of input signals on either bipolar ( $\pm 5V$ ) or single (5V) supply. Special temperature drift compensation circuitry is included on-chip. In log-ratio applications, the signal current may be from a high impedance source such as a photodiode or resistor in series with a low impedance voltage source. The reference current is provided by a resistor in series with a precision internal voltage reference, photo diode, or active current source.

The output signal at  $V_{LOGOUT}$  has a scale factor of 0.375V/decade of input current, which limits the output so that it fits within a 5V or 10V range. The output can be scaled and offset with one of the available additional amplifiers, so it matches a wide variety of ADC input ranges. Stable DC performance allows accurate measurement of low-level signals over a wide temperature range. The LOG114 is specified over a  $-5^{\circ}C$  to  $75^{\circ}C$  temperature range and can operate from  $-40^{\circ}C$  to  $85^{\circ}C$ .

### Package Information

| PART NUMBER | PACKAGE <sup>(1)</sup> | PACKAGE SIZE <sup>(2)</sup> |
|-------------|------------------------|-----------------------------|
| LOG114      | RGV (VQFN, 16)         | 4mm $\times$ 4mm            |

- (1) For more information, see [Section 10](#).
- (2) The package size (length  $\times$  width) is a nominal value and includes pins, where applicable.



- A. Thermally dependent  $R_1$  and  $R_2$  provide temperature compensation.
- B.  $V_{LOGOUT} = 0.375 \times \log(I_1/I_2)$ .
- C.  $V_{OS} = 0.375 \times K \times \log(I_1/I_2)$ ,  $K = 1 + R_6/R_5$ .
- D. Differential Amplifier ( $A_3$ ) Gain = 6.25

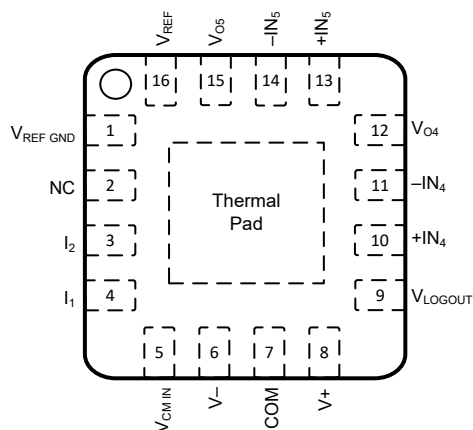
## Functional Block Diagram



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## 4 Pin Configuration



Not to scale

**Figure 4-1. RGV Package, 16-Pin VQFN (Top View)**

| PIN                 |     | TYPE   | DESCRIPTION                                      |
|---------------------|-----|--------|--------------------------------------------------|
| NAME                | NO. |        |                                                  |
| COM                 | 7   | Input  | Reference Voltage for the differential amplifier |
| +IN <sub>4</sub>    | 10  | Input  | Auxiliary op-amp voltage non-inverting input     |
| -IN <sub>4</sub>    | 11  | Input  | Auxiliary op-amp voltage inverting input         |
| +IN <sub>5</sub>    | 13  | Input  | Auxiliary op-amp voltage non-inverting input     |
| -IN <sub>5</sub>    | 14  | Input  | Auxiliary op-amp voltage inverting input         |
| NC                  | 2   | N/A    | No Connection                                    |
| I <sub>1</sub>      | 4   | Input  | Current input for logarithm numerator            |
| I <sub>2</sub>      | 3   | Input  | Current input for logarithm denominator          |
| V+                  | 8   | Power  | Positive supply voltage                          |
| V-                  | 6   | Power  | Negative supply voltage                          |
| V <sub>CM IN</sub>  | 5   | Input  | Input common-mode voltage                        |
| V <sub>LOGOUT</sub> | 9   | Output | Logarithmic difference amplifier output          |
| V <sub>O4</sub>     | 12  | Output | Auxiliary op-amp voltage output                  |
| V <sub>O5</sub>     | 15  | Output | Auxiliary op-amp voltage output                  |
| V <sub>REF</sub>    | 16  | Power  | 2.5V reference voltage                           |
| V <sub>REFGND</sub> | 1   | Ground | Reference voltage ground                         |
| Thermal Pad         | PAD | —      | Thermal Pad. Connect to V-                       |

## 5 Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

|                  |                                                                        |                        | MIN                     | MAX                     | UNIT |
|------------------|------------------------------------------------------------------------|------------------------|-------------------------|-------------------------|------|
| V <sub>S</sub>   | Supply voltage, V <sub>S</sub> = (V <sub>+</sub> ) – (V <sub>–</sub> ) |                        |                         | 12                      | V    |
|                  | Signal input terminals                                                 | Voltage <sup>(2)</sup> | (V <sub>–</sub> ) – 0.5 | (V <sub>+</sub> ) + 0.5 | V    |
|                  |                                                                        | Current <sup>(2)</sup> |                         | ±10                     | mA   |
|                  | Output short-circuit <sup>(3)</sup>                                    |                        | Continuous              |                         |      |
| T <sub>A</sub>   | Operating temperature                                                  |                        | –40                     | 85                      | °C   |
| T <sub>J</sub>   | Junction temperature                                                   |                        |                         | 150                     | °C   |
| T <sub>stg</sub> | Storage temperature                                                    |                        | –55                     | 125                     | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5V beyond the supply rails should be current-limited to 10mA or less.
- (3) Short-circuit to ground, one amplifier per package.

### 5.2 ESD Ratings

|                    |                         |                                                                                | VALUE | UNIT |
|--------------------|-------------------------|--------------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | 2000  | V    |
|                    |                         | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | 1500  |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                |                       | MIN  | NOM | MAX  | UNIT |
|----------------|-----------------------|------|-----|------|------|
| V <sub>S</sub> | Supply voltage        | ±2.4 |     | ±5.5 | V    |
| T <sub>A</sub> | Specified temperature | –5   |     | 75   | °C   |
|                | Operating temperature | –40  |     | 85   | °C   |

### 5.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | LOG114     | UNIT |
|-------------------------------|----------------------------------------------|------------|------|
|                               |                                              | RGV (VQFN) |      |
|                               |                                              | 16 PINS    |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 46.6       | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 42.9       | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 21.8       | °C/W |
| ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 1.1        | °C/W |
| ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 21.8       | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | 6.6        | °C/W |

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

## 5.5 Electrical Characteristics (±5V)

All specifications at  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 5\text{V}$ ,  $V_{\text{LOGOUT}} R_L = 10\text{k}\Omega$ ,  $V_{\text{CM}} = \text{GND}$ , unless otherwise noted.

| PARAMETER                             |                                             | TEST CONDITIONS                                             |                                                             | MIN                                         | TYP                | MAX | UNIT     |  |
|---------------------------------------|---------------------------------------------|-------------------------------------------------------------|-------------------------------------------------------------|---------------------------------------------|--------------------|-----|----------|--|
| CORE LOG FUNCTION                     |                                             |                                                             |                                                             |                                             |                    |     |          |  |
|                                       | Core log function                           | $I_{\text{IN}}/V_{\text{OUT}}$ Equation                     |                                                             | $V_{\text{O}} = (0.375) \log(I_1/I_2)$      |                    |     | V        |  |
| LOG CONFORMITY ERROR                  |                                             |                                                             |                                                             |                                             |                    |     |          |  |
|                                       | Log conformity error <sup>(1)</sup>         | 1nA to 100μA (5 decades)                                    |                                                             | 0.1                                         | 0.3                |     | %        |  |
|                                       |                                             |                                                             |                                                             | 0.009                                       | 0.026              |     | dB       |  |
|                                       |                                             |                                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ | 0.1                                         | 0.4                |     | %        |  |
|                                       |                                             | 100pA to 3.5mA (7.5 decades)                                |                                                             | 2.2                                         |                    |     | %        |  |
|                                       |                                             |                                                             |                                                             | 0.19                                        |                    |     | dB       |  |
|                                       |                                             |                                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ | 2.3                                         |                    |     | %        |  |
|                                       |                                             | 1mA to 10mA                                                 |                                                             | See <a href="#">typical characteristics</a> |                    |     |          |  |
|                                       |                                             |                                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ | See <a href="#">typical characteristics</a> |                    |     |          |  |
| TRANSFER FUNCTION (GAIN)              |                                             |                                                             |                                                             |                                             |                    |     |          |  |
|                                       | Initial scaling factor                      | 100pA to 10mA                                               |                                                             | 0.375                                       |                    |     | V/decade |  |
|                                       | Scaling factor error <sup>(2)</sup>         | 1nA to 100μA                                                |                                                             | 0.4                                         | ±2.5               |     | %        |  |
|                                       |                                             |                                                             |                                                             | 0.035                                       | 0.21               |     | dB       |  |
|                                       |                                             |                                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ | 1.5                                         | ±3.5               |     | %        |  |
|                                       |                                             |                                                             | $T_{\text{A}} = 15^{\circ}\text{C}$ to $50^{\circ}\text{C}$ | 0.7                                         | ±3                 |     | %        |  |
| INPUT, $A_1$ and $A_2$                |                                             |                                                             |                                                             |                                             |                    |     |          |  |
| $V_{\text{OS}}$                       | Offset voltage                              |                                                             |                                                             | ±1                                          | ±4                 |     | mV       |  |
| $dV_{\text{OS}}/dT$                   | Offset voltage drift                        | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ |                                                             | ±15                                         |                    |     | μV/°C    |  |
| PSRR                                  | Offset voltage vs power supply              | $V_{\text{S}} = \pm 2.25\text{V}$ to $\pm 5.5\text{V}$      |                                                             | 75                                          | 400                |     | μV/V     |  |
| $I_{\text{B}}$                        | Input bias current                          |                                                             |                                                             | ±5                                          |                    |     | pA       |  |
|                                       |                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ |                                                             | Doubles every 10°C                          |                    |     |          |  |
| $V_{\text{CM}}$                       | Input common-mode range                     |                                                             |                                                             | $(V-) + 1.5\text{V}$                        | $(V+) - 1.5$       |     | V        |  |
| $e_{\text{n}}$                        | Voltage noise                               | f = 0.1Hz to 10kHz                                          |                                                             | 3                                           |                    |     | μVrms    |  |
|                                       |                                             | f = 1kHz                                                    |                                                             | 30                                          |                    |     | nV/√Hz   |  |
| $i_{\text{n}}$                        | Current noise                               | f = 1kHz                                                    |                                                             | 4                                           |                    |     | fA/√Hz   |  |
| OUTPUT, $A_3$ ( $V_{\text{LOGOUT}}$ ) |                                             |                                                             |                                                             |                                             |                    |     |          |  |
| $V_{\text{OSO}}$                      | Output offset voltage                       |                                                             |                                                             | ±11                                         | ±50                |     | mV       |  |
|                                       |                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ |                                                             | ±15                                         | ±65                |     | mV       |  |
| FSO                                   | Full-scale output <sup>(3)</sup>            |                                                             |                                                             | $(V-) + 0.6$                                | $(V+) - 0.6$       |     | V        |  |
| GBW                                   | Gain-bandwidth product                      | $I_{\text{IN}} = 1\mu\text{A}$                              |                                                             | 50                                          |                    |     | MHz      |  |
| $I_{\text{SC}}$                       | Short-circuit current                       |                                                             |                                                             | ±18                                         |                    |     | mA       |  |
|                                       | Capacitive load                             |                                                             |                                                             | 100                                         |                    |     | pF       |  |
| OP AMP, $A_4$ and $A_5$               |                                             |                                                             |                                                             |                                             |                    |     |          |  |
| $V_{\text{OS}}$                       | Input offset voltage                        |                                                             |                                                             | ±250                                        | ±1000              |     | μV       |  |
| $dV_{\text{OS}}/dT$                   | Input offset voltage vs temperature         | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ |                                                             | ±2                                          |                    |     | μV/°C    |  |
| PSRR                                  | Input offset voltage vs supply              | $V_{\text{S}} = \pm 4.5\text{V}$ to $\pm 5.5\text{V}$       |                                                             | 30                                          | 250                |     | μV/V     |  |
| CMRR                                  | Input offset voltage vs common-mode voltage |                                                             |                                                             | 74                                          |                    |     | dB       |  |
| $I_{\text{B}}$                        | Input bias current                          |                                                             |                                                             | −1                                          |                    |     | μA       |  |
| $I_{\text{OS}}$                       | Input offset current                        |                                                             |                                                             | ±0.05                                       |                    |     | μA       |  |
|                                       | Input voltage range                         |                                                             |                                                             | $(V-)$                                      | $(V+) - 2\text{V}$ |     | V        |  |
|                                       | Input voltage noise                         | f = 0.1Hz to 10kHz                                          |                                                             | 2                                           |                    |     | μVpp     |  |
|                                       |                                             | f = 1kHz                                                    |                                                             | 13                                          |                    |     | nV/√Hz   |  |
| $i_{\text{n}}$                        | Current noise                               | f = 1kHz                                                    |                                                             | 2                                           |                    |     | pA/√Hz   |  |

## 5.5 Electrical Characteristics (±5V) (continued)

All specifications at  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 5\text{V}$ ,  $V_{\text{LOGOUT}} R_L = 10\text{k}\Omega$ ,  $V_{\text{CM}} = \text{GND}$ , unless otherwise noted.

| PARAMETER                    |                                                                | TEST CONDITIONS                                                           |                                    | MIN                                         | TYP         | MAX | UNIT   |
|------------------------------|----------------------------------------------------------------|---------------------------------------------------------------------------|------------------------------------|---------------------------------------------|-------------|-----|--------|
| A <sub>OL</sub>              | Open-loop voltage gain                                         |                                                                           |                                    | 100                                         |             |     | dB     |
| GBW                          | Gain-bandwidth product                                         |                                                                           |                                    | 15                                          |             |     | MHz    |
| SR                           | Slew rate                                                      |                                                                           |                                    | 5                                           |             |     | V/μs   |
| t <sub>S</sub>               | Settling time 0.01%                                            | G = -1, 3V step, C <sub>L</sub> = 100pF                                   |                                    | 1.5                                         |             |     | μs     |
|                              | Rated output                                                   |                                                                           |                                    | (V-) + 0.5V                                 | (V+) – 0.5V |     | V      |
| I <sub>SC</sub>              | Short-circuit current                                          | Sourcing                                                                  |                                    | +4                                          |             |     | mA     |
|                              |                                                                | Sinking                                                                   |                                    | –10                                         |             |     | mA     |
| TOTAL ERROR                  |                                                                |                                                                           |                                    |                                             |             |     |        |
|                              | Total error <sup>(4) (5)</sup>                                 |                                                                           |                                    | See <a href="#">typical characteristics</a> |             |     |        |
| FREQUENCY RESPONSE, Core Log |                                                                |                                                                           |                                    |                                             |             |     |        |
|                              | BW, 3 dB, I <sub>1</sub> or I <sub>2</sub> <sup>(6)</sup>      | I <sub>AC</sub> = 10% of I <sub>DC</sub> value,<br>I <sub>REF</sub> = 1μA | 1nA                                | 5                                           |             | kHz |        |
|                              |                                                                |                                                                           | 10nA                               | 12                                          |             |     |        |
|                              |                                                                |                                                                           | 100nA                              | 120                                         |             |     |        |
|                              |                                                                |                                                                           | 1μA                                | 2.3                                         |             | MHz |        |
|                              |                                                                |                                                                           | 10μA to 10mA                       | > 5                                         |             |     |        |
|                              | Step response, I <sub>1</sub> or I <sub>2</sub> <sup>(6)</sup> | 8nA to 240nA (ratio 1:30)                                                 | Increasing, I <sub>REF</sub> = 1μA | 0.8                                         |             | μs  |        |
|                              |                                                                |                                                                           | Decreasing, I <sub>REF</sub> = 1μA | 6                                           |             |     |        |
|                              |                                                                | 10nA to 100nA (ratio 1:10)                                                | Increasing, I <sub>REF</sub> = 1μA | 1.5                                         |             |     |        |
|                              |                                                                |                                                                           | Decreasing, I <sub>REF</sub> = 1μA | 5                                           |             |     |        |
|                              |                                                                | 10nA to 1μA (ratio 1:100)                                                 | Increasing, I <sub>REF</sub> = 1μA | 0.25                                        |             |     |        |
|                              |                                                                |                                                                           | Decreasing, I <sub>REF</sub> = 1μA | 4                                           |             |     |        |
|                              |                                                                | 1mA to 10mA (ratio 1:10)                                                  | Increasing, I <sub>REF</sub> = 1μA | 1                                           |             |     |        |
|                              |                                                                |                                                                           | Decreasing, I <sub>REF</sub> = 1μA | 1                                           |             |     |        |
| VOLTAGE REFERENCE            |                                                                |                                                                           |                                    |                                             |             |     |        |
|                              | Bandgap voltage                                                |                                                                           |                                    | 2.5                                         |             |     | V      |
|                              | Error                                                          |                                                                           |                                    | ±0.15                                       |             | ±1  | %      |
|                              |                                                                | T <sub>A</sub> = -5°C to 75°C                                             |                                    | ±25                                         |             |     | ppm/°C |
|                              |                                                                | V <sub>S</sub> = ±4.5V to ±5.5V                                           |                                    | ±30                                         |             |     | ppm/V  |
|                              |                                                                | I <sub>O</sub> = ±2mA                                                     |                                    | ±200                                        |             |     | ppm/mA |
|                              | Short-circuit current                                          |                                                                           |                                    | ±10                                         |             |     | mA     |
| POWER SUPPLY                 |                                                                |                                                                           |                                    |                                             |             |     |        |
| I <sub>Q</sub>               | Quiescent current                                              | I <sub>O</sub> = 0                                                        |                                    | ±10                                         |             | ±15 | mA     |

- (1) Log conformity error is peak deviation from the best-fit straight line of  $V_O$  vs  $\text{Log}(I_1/I_2)$  curve expressed as a percent of peak-to-peak full-scale output. Scale factor, K, equals 0.375V output per decade of input current.
- (2) Scale factor of core log function is trimmed to 0.375V output per decade change of input current.
- (3) Specified by design.
- (4) Worst-case total error for any ratio of  $I_1/I_2$ , as the largest of the two errors, when  $I_1$  and  $I_2$  are considered separately
- (5) Total error includes offset voltage, bias current, gain, and log conformity.
- (6) Small signal bandwidth (3dB) and transient response are a function of the level of input current. Smaller input current amplitude results in lower bandwidth.

## 5.6 Electrical Characteristics (5V)

All specifications at  $T_A = 25^\circ\text{C}$ ,  $V_S = 5\text{V}$ ,  $V_{\text{LOGOUT}} R_L = 10\text{k}\Omega$ ,  $V_{\text{CM}} = \text{GND}$ , unless otherwise noted.

| PARAMETER                                     |                                             | TEST CONDITIONS                                             |                                                             | MIN                                                    | TYP | MAX                  | UNIT     |
|-----------------------------------------------|---------------------------------------------|-------------------------------------------------------------|-------------------------------------------------------------|--------------------------------------------------------|-----|----------------------|----------|
| CORE LOG FUNCTION                             |                                             |                                                             |                                                             |                                                        |     |                      |          |
|                                               | Core log function                           | $I_{\text{IN}}/V_{\text{OUT}}$ Equation                     |                                                             | $V_{\text{O}} = (0.375) \log(I_1/I_2) + V_{\text{CM}}$ |     | V                    |          |
| LOG CONFORMITY ERROR                          |                                             |                                                             |                                                             |                                                        |     |                      |          |
|                                               | Log conformity error <sup>(1)</sup>         | 1nA to 100μA (5 decades)                                    |                                                             | 0.1                                                    |     | 0.3                  | %        |
|                                               |                                             |                                                             |                                                             | 0.009                                                  |     | 0.026                | dB       |
|                                               |                                             |                                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ | 0.1                                                    |     | 0.4                  | %        |
|                                               |                                             | 100pA to 3.5mA (7.5 decades)                                |                                                             | 2.2                                                    |     |                      | %        |
|                                               |                                             |                                                             |                                                             | 0.19                                                   |     |                      | dB       |
|                                               |                                             |                                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ | 2.3                                                    |     |                      | %        |
|                                               |                                             | 1mA to 10mA                                                 |                                                             | See <a href="#">typical characteristics</a>            |     |                      |          |
|                                               |                                             |                                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ | See <a href="#">typical characteristics</a>            |     |                      |          |
| TRANSFER FUNCTION (GAIN)                      |                                             |                                                             |                                                             |                                                        |     |                      |          |
|                                               | Initial scaling factor                      | 100pA to 10mA                                               |                                                             | 0.375                                                  |     |                      | V/decade |
|                                               | Scaling factor error <sup>(2)</sup>         | 1nA to 100μA                                                |                                                             | 0.4                                                    |     | ±2.5                 | %        |
|                                               |                                             |                                                             |                                                             | 0.035                                                  |     | 0.21                 | dB       |
|                                               |                                             |                                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ | 1.5                                                    |     | ±3.5                 | %        |
|                                               |                                             |                                                             | $T_{\text{A}} = 15^{\circ}\text{C}$ to $50^{\circ}\text{C}$ | 0.7                                                    |     | ±3                   | %        |
| INPUT, A <sub>1</sub> and A <sub>2</sub>      |                                             |                                                             |                                                             |                                                        |     |                      |          |
| V <sub>OS</sub>                               | Offset voltage                              |                                                             |                                                             | ±1                                                     |     | ±7                   | mV       |
| dV <sub>OS</sub> /dT                          | Offset voltage vs temperature               | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ |                                                             | ±30                                                    |     |                      | μV/°C    |
| PSRR                                          | Offset voltage vs power supply              | $V_{\text{S}} = 4.5\text{V}$ to $5.5\text{V}$               |                                                             | 300                                                    |     |                      | μV/V     |
| I <sub>B</sub>                                | Input bias current                          | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ |                                                             | ±5                                                     |     |                      | pA       |
| V <sub>CM</sub>                               | Input common-mode range                     |                                                             |                                                             | $(V-) + 1.5\text{V}$                                   |     | $(V+) - 1.5$         | V        |
| e <sub>n</sub>                                | Voltage noise                               | f = 0.1Hz to 10kHz                                          |                                                             | 3                                                      |     |                      | μVrms    |
|                                               |                                             | f = 1kHz                                                    |                                                             | 30                                                     |     |                      | nV/√Hz   |
| i <sub>n</sub>                                | Current noise                               | f = 1kHz                                                    |                                                             | 4                                                      |     |                      | fA/√Hz   |
| OUTPUT, A <sub>3</sub> (V <sub>LOGOUT</sub> ) |                                             |                                                             |                                                             |                                                        |     |                      |          |
| V <sub>OSO</sub>                              | Output offset voltage                       |                                                             |                                                             | ±14                                                    |     | ±65                  | mV       |
|                                               |                                             | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ |                                                             | ±18                                                    |     | ±80                  | mV       |
| FSO                                           | Full-scale output <sup>(3)</sup>            |                                                             |                                                             | $(V-) + 0.6$                                           |     | $(V+) - 0.6$         | V        |
| GBW                                           | Gain bandwidth product                      | $I_{\text{IN}} = 1\mu\text{A}$                              |                                                             | 50                                                     |     |                      | MHz      |
| I <sub>SC</sub>                               | Short-circuit current                       |                                                             |                                                             | ±18                                                    |     |                      | mA       |
|                                               | Capacitive load                             |                                                             |                                                             | 100                                                    |     |                      | pF       |
| OP AMP, A <sub>4</sub> and A <sub>5</sub>     |                                             |                                                             |                                                             |                                                        |     |                      |          |
| V <sub>OS</sub>                               | Input offset voltage                        |                                                             |                                                             | ±250                                                   |     | ±4000                | μV       |
| dV <sub>OS</sub> /dT                          | Input offset voltage vs temperature         | $T_{\text{A}} = -5^{\circ}\text{C}$ to $75^{\circ}\text{C}$ |                                                             | ±2                                                     |     |                      | μV/°C    |
| PSRR                                          | Input offset voltage vs supply              | $V_{\text{S}} = 4.8\text{V}$ to $5.5\text{V}$               |                                                             | 30                                                     |     |                      | μV/V     |
| CMRR                                          | Input offset voltage vs common-mode voltage |                                                             |                                                             | 70                                                     |     |                      | dB       |
| I <sub>B</sub>                                | Input bias current                          |                                                             |                                                             | −1                                                     |     |                      | μA       |
| I <sub>OS</sub>                               | Input offset current                        |                                                             |                                                             | ±0.05                                                  |     |                      | μA       |
|                                               | Input voltage range                         |                                                             |                                                             | $(V-)$                                                 |     | $(V+) - 1.5\text{V}$ | V        |
|                                               | Input voltage noise                         | f = 0.1Hz to 10kHz                                          |                                                             | 1                                                      |     |                      | μVpp     |
|                                               |                                             | f = 1kHz                                                    |                                                             | 28                                                     |     |                      | nV/√Hz   |

## 5.6 Electrical Characteristics (5V) (continued)

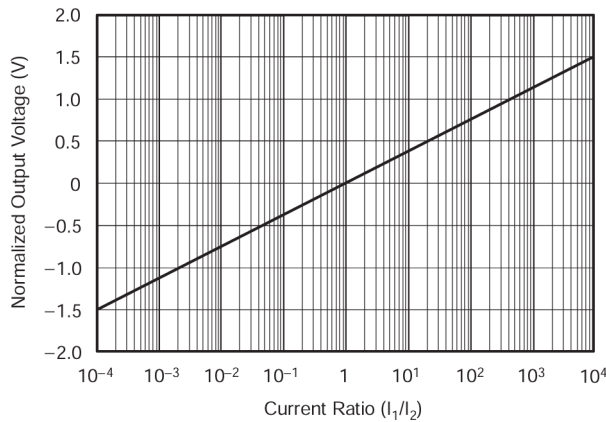
All specifications at  $T_A = 25^\circ\text{C}$ ,  $V_S = 5\text{V}$ ,  $V_{\text{LOGOUT}} R_L = 10\text{k}\Omega$ ,  $V_{\text{CM}} = \text{GND}$ , unless otherwise noted.

| PARAMETER                    |                                                                | TEST CONDITIONS                                                           |                                    | MIN                                         | TYP | MAX         | UNIT   |
|------------------------------|----------------------------------------------------------------|---------------------------------------------------------------------------|------------------------------------|---------------------------------------------|-----|-------------|--------|
| i <sub>n</sub>               | Current noise                                                  | f = 1kHz                                                                  |                                    |                                             | 2   |             | pA/√Hz |
| A <sub>OL</sub>              | Open-loop voltage gain                                         |                                                                           |                                    |                                             | 100 |             | dB     |
| GBW                          | Gain-bandwidth product                                         |                                                                           |                                    |                                             | 15  |             | MHz    |
| SR                           | Slew rate                                                      |                                                                           |                                    |                                             | 5   |             | V/μs   |
| t <sub>s</sub>               | Settling time 0.01%                                            | G = -1, 3V step, C <sub>L</sub> = 100pF                                   |                                    |                                             | 1.5 |             | μs     |
|                              | Rated output                                                   |                                                                           |                                    | (V-) + 0.5V                                 |     | (V+) – 0.5V | V      |
| I <sub>SC</sub>              | Short-circuit current                                          | Sourcing                                                                  |                                    |                                             | +4  |             | mA     |
|                              |                                                                | Sinking                                                                   |                                    |                                             | –10 |             | mA     |
| TOTAL ERROR                  |                                                                |                                                                           |                                    |                                             |     |             |        |
|                              | Total error <sup>(4) (5)</sup>                                 |                                                                           |                                    | See <a href="#">typical characteristics</a> |     |             |        |
| FREQUENCY RESPONSE, Core Log |                                                                |                                                                           |                                    |                                             |     |             |        |
|                              | BW, 3 dB, I <sub>1</sub> or I <sub>2</sub> <sup>(6)</sup>      | I <sub>AC</sub> = 10% of I <sub>DC</sub> value,<br>I <sub>REF</sub> = 1μA | 1nA                                | 5                                           |     | kHz         |        |
|                              |                                                                |                                                                           | 10nA                               | 12                                          |     |             |        |
|                              |                                                                |                                                                           | 100nA                              | 120                                         |     |             |        |
|                              |                                                                |                                                                           | 1μA                                | 2.3                                         |     | MHz         |        |
|                              |                                                                |                                                                           | 10μA to 10mA (ratio 1:1k)          | > 5                                         |     |             |        |
|                              | Step response, I <sub>1</sub> or I <sub>2</sub> <sup>(6)</sup> | 8nA to 240nA (ratio 1:30)                                                 | Increasing, I <sub>REF</sub> = 1μA | 0.8                                         |     | μs          |        |
|                              |                                                                |                                                                           | Decreasing, I <sub>REF</sub> = 1μA | 6                                           |     |             |        |
|                              |                                                                | 10nA to 100nA (ratio 1:10)                                                | Increasing, I <sub>REF</sub> = 1μA | 1.5                                         |     |             |        |
|                              |                                                                |                                                                           | Decreasing, I <sub>REF</sub> = 1μA | 5                                           |     |             |        |
|                              |                                                                | 10nA to 1μA (ratio 1:100)                                                 | Increasing, I <sub>REF</sub> = 1μA | 0.25                                        |     |             |        |
|                              |                                                                |                                                                           | Decreasing, I <sub>REF</sub> = 1μA | 4                                           |     |             |        |
|                              |                                                                | 1mA to 10mA (ratio 1:10)                                                  | Increasing, I <sub>REF</sub> = 1μA | 1                                           |     |             |        |
|                              |                                                                |                                                                           | Decreasing, I <sub>REF</sub> = 1μA | 1                                           |     |             |        |
| VOLTAGE REFERENCE            |                                                                |                                                                           |                                    |                                             |     |             |        |
|                              | Bandgap voltage                                                |                                                                           |                                    | 2.5                                         |     |             | V      |
|                              | Error                                                          |                                                                           |                                    | ±0.15                                       |     | ±1          | %      |
|                              |                                                                | T <sub>A</sub> = -5°C to 75°C                                             |                                    | ±25                                         |     |             | ppm/°C |
|                              |                                                                | V <sub>S</sub> = 4.8V to 11V                                              |                                    | ±30                                         |     |             | ppm/V  |
|                              |                                                                | I <sub>O</sub> = ±2mA                                                     |                                    | ±200                                        |     |             | ppm/mA |
| I <sub>SC</sub>              | Short-circuit current                                          |                                                                           |                                    | ±10                                         |     |             | mA     |
| POWER SUPPLY                 |                                                                |                                                                           |                                    |                                             |     |             |        |
| I <sub>Q</sub>               | Quiescent current                                              | I <sub>O</sub> = 0                                                        |                                    | ±10                                         |     | ±15         | mA     |

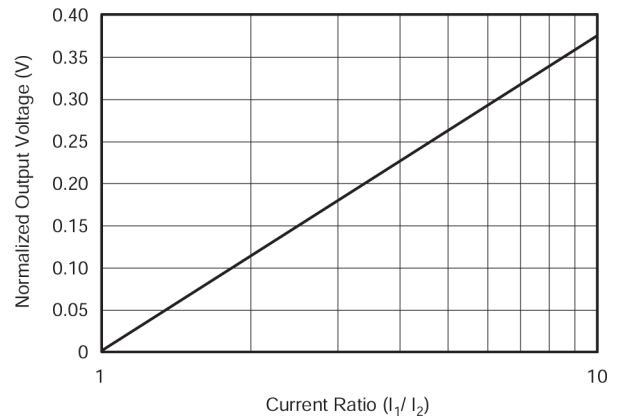
- (1) Log conformity error is peak deviation from the best-fit straight line of  $V_O$  vs  $\text{Log}(I_1/I_2)$  curve expressed as a percent of peak-to-peak full-scale output. Scale factor,  $K$ , equals 0.375V output per decade of input current.
- (2) Scale factor of core log function is trimmed to 0.375V output per decade change of input current.
- (3) Specified by design.
- (4) Worst-case total error for any ratio of  $I_1/I_2$ , as the largest of the two errors, when  $I_1$  and  $I_2$  are considered separately.
- (5) Total error includes offset voltage, bias current, gain, and log conformity.
- (6) Small signal bandwidth (3dB) and transient response are a function of the level of input current. Smaller input current amplitude results in lower bandwidth.

## 5.7 Typical Characteristics: $V_S = \pm 5V$

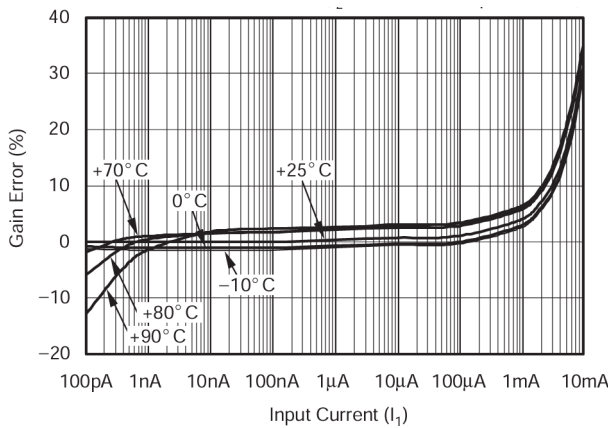
All specifications at  $T_A = 25^\circ C$ ,  $V_{LOGOUT} R_L = 10k\Omega$ ,  $V_{CM} = GND$ , unless otherwise noted. For AC measurements, small signal means up to approximately 10% of DC level.



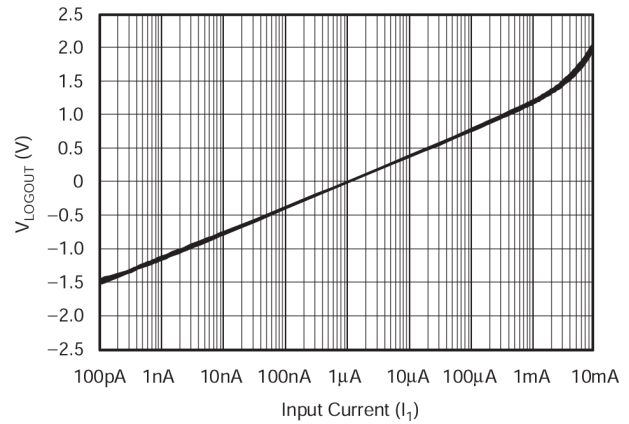
**Figure 5-1. Normalized Transfer Function**



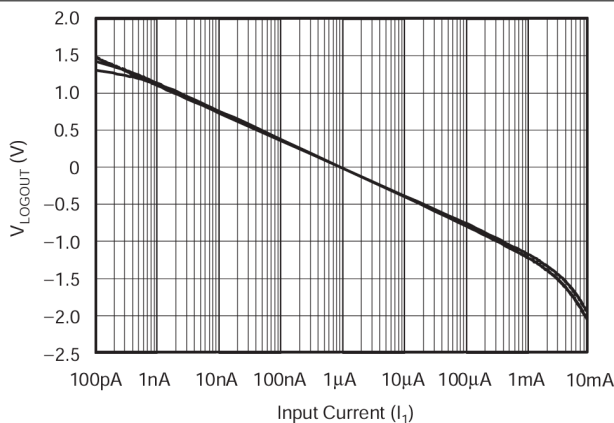
**Figure 5-2. One Cycle of Normalized Transfer Function**



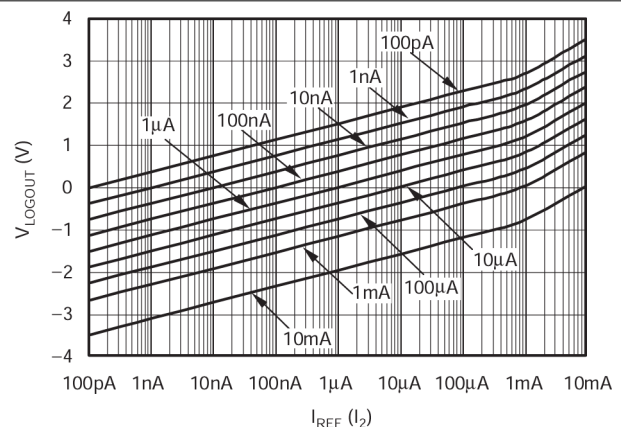
**Figure 5-3. Scaling Factor Error ( $I_2 = \text{Reference } 100pA \text{ to } 10mA$ )**



**Figure 5-4.  $V_{LOGOUT}$  vs  $I_1$  Input ( $I_2 = 1\mu A$ )**



**Figure 5-5.  $V_{LOGOUT}$  vs  $I_2$  Input ( $I_1 = 1\mu A$ )**



**Figure 5-6.  $V_{LOGOUT}$  vs  $I_{REF}$**

## 5.7 Typical Characteristics: $V_S = \pm 5V$ (continued)

All specifications at  $T_A = 25^\circ C$ ,  $V_{LOGOUT} R_L = 10k\Omega$ ,  $V_{CM} = GND$ , unless otherwise noted. For AC measurements, small signal means up to approximately 10% of DC level.

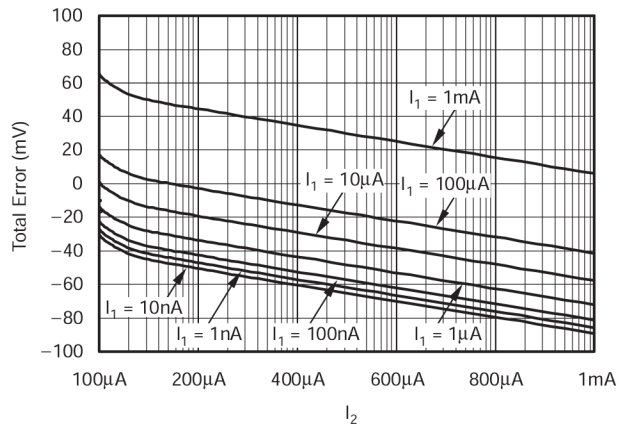


Figure 5-7. Average Total Error at  $80^\circ C$

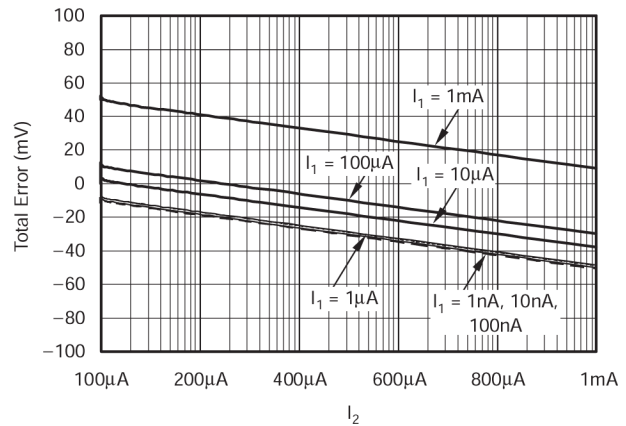


Figure 5-8. Average Total Error at  $25^\circ C$

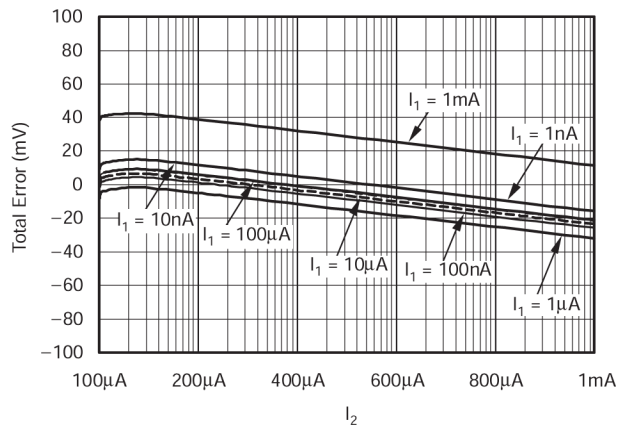


Figure 5-9. Average Total Error at  $-10^\circ C$

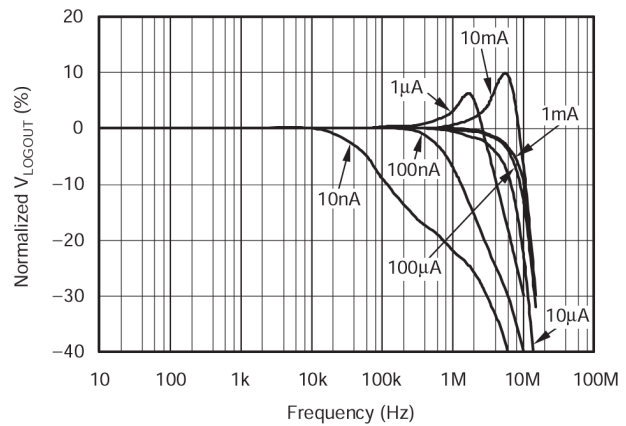


Figure 5-10. Small-Signal  $V_{LOGOUT}$

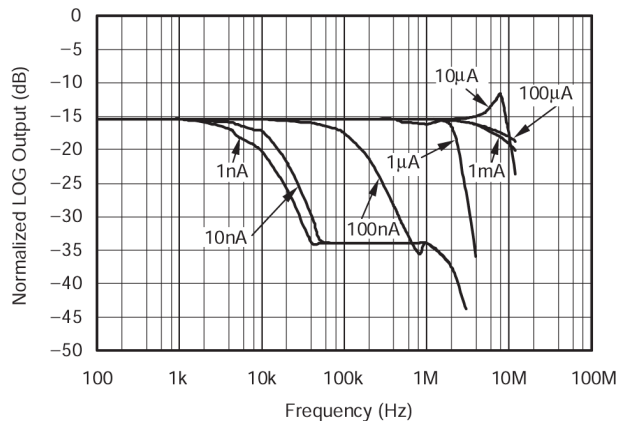


Figure 5-11. Small-Signal AC Response  $I_1$  (10% Sine Modulation)

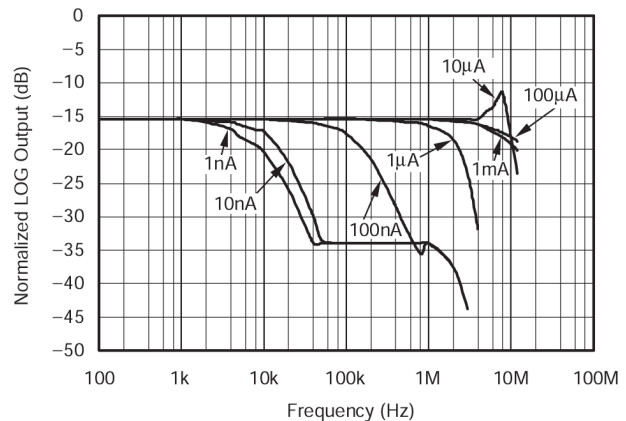
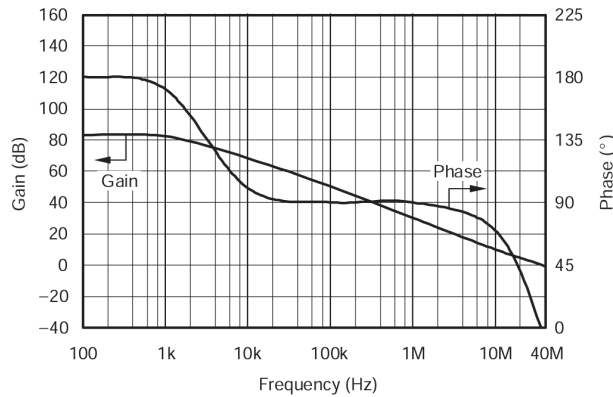


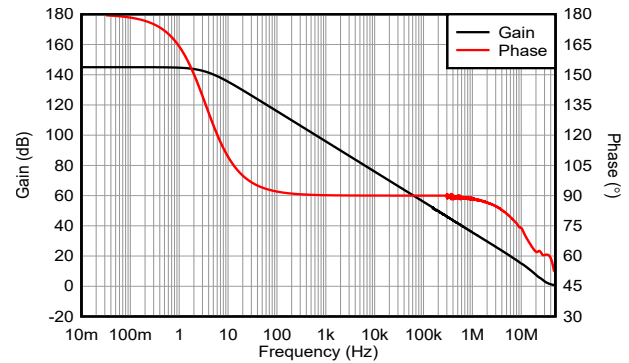
Figure 5-12. Small-Signal AC Response  $I_2$  (10% Sine Modulation)

## 5.7 Typical Characteristics: $V_S = \pm 5V$ (continued)

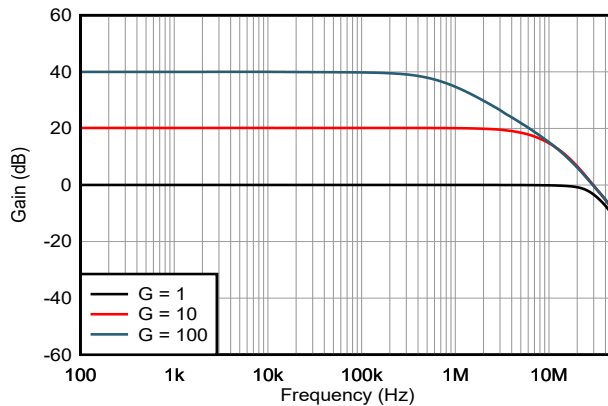
All specifications at  $T_A = 25^\circ C$ ,  $V_{LOGOUT} R_L = 10k\Omega$ ,  $V_{CM} = GND$ , unless otherwise noted. For AC measurements, small signal means up to approximately 10% of DC level.



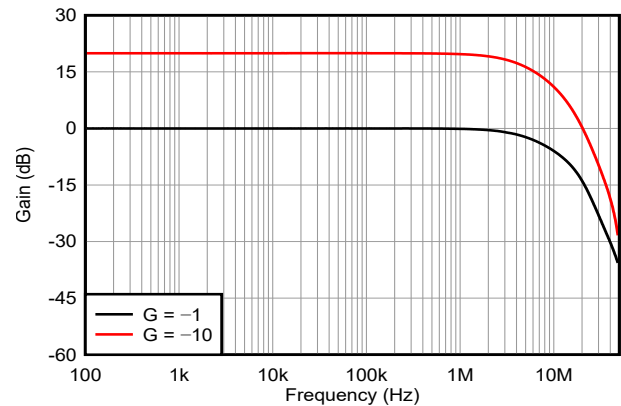
**Figure 5-13. A<sub>3</sub> Gain and Phase vs Frequency**



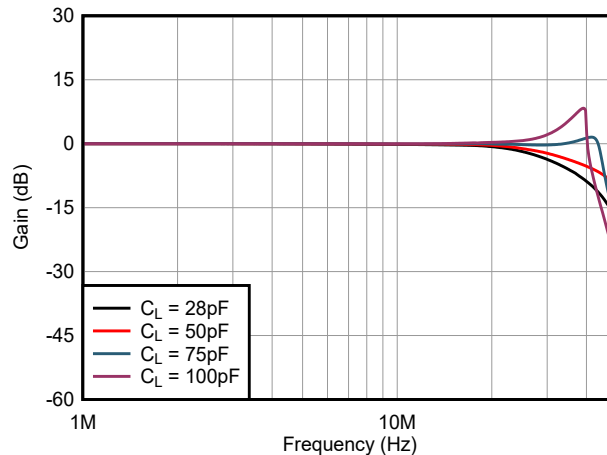
**Figure 5-14. A<sub>4</sub> and A<sub>5</sub> Gain and Phase vs Frequency**



**Figure 5-15. A<sub>4</sub> and A<sub>5</sub> Noninverting Closed-Loop Response**



**Figure 5-16. A<sub>4</sub> and A<sub>5</sub> Inverting Closed-Loop Response**



**Figure 5-17. A<sub>4</sub> and A<sub>5</sub> Capacitive Load Response**

## 6 Detailed Description

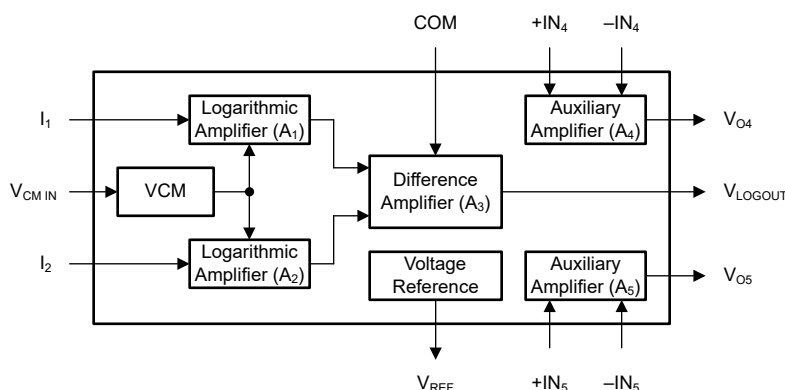
### 6.1 Overview

The LOG114 is specifically designed for measuring low-level and wide dynamic range currents in communications, lasers, medical, and industrial systems. The device computes the logarithm or log-ratio of an input current or voltage relative to a reference current or voltage (logarithmic transimpedance amplifier).

High precision is designed for over a wide dynamic range of input signals on either bipolar ( $\pm 5V$ ) or single (5V) supply. Special temperature drift compensation circuitry is included on-chip. In log-ratio applications, the signal current can be from a high impedance source such as a photodiode or resistor in series with a low impedance voltage source. The reference current is provided by a resistor in series with a precision internal voltage reference, photo diode, or active current source.

The output signal at  $V_{LOGOUT}$  has a scale factor of 0.375V/decade of input current, which limits the output so that the output signal fits within a 5V or 10V range. The output can be digitized directly, or scaled and offset with one of the available additional amplifiers, to match a wide variety of ADC input ranges. Stable DC performance allows accurate measurement of low-level signals over a wide temperature range. The LOG114 is specified over a  $-5^{\circ}C$  to  $75^{\circ}C$  temperature range and can operate from  $-40^{\circ}C$  to  $85^{\circ}C$ .

### 6.2 Functional Block Diagram



### 6.3 Feature Description

#### 6.3.1 Logarithmic and Difference Amplifier

The LOG114 uses two matched logarithmic amplifiers ( $A_1$  and  $A_2$  with logging diodes in the feedback loops) to generate the outputs  $\log(I_1)$  and  $\log(I_2)$ , respectively. The gain of 6.25 differential amplifier ( $A_3$ ) subtracts the output of  $A_2$  from the output of  $A_1$ , resulting in  $[\log(I_1) - \log(I_2)]$ , or  $\log(I_1/I_2)$ . The symmetrical design of the  $A_1$  and  $A_2$  logarithmic amps allows  $I_1$  and  $I_2$  to be used interchangeably, and provides good bandwidth and phase characteristics with frequency.

#### 6.3.2 COM Voltage Range

The voltage on the COM pin is used to bias the differential amplifier,  $A_3$ , within its linear range. This voltage can provide an asymmetrical offset of the  $V_{LOGOUT}$  voltage.

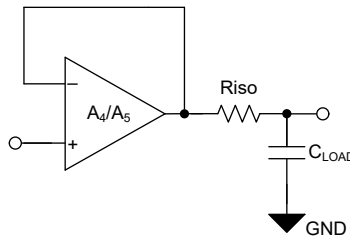
#### 6.3.3 $V_{CM IN}$

The  $V_{CM IN}$  pin is used to bias the  $A_1$  and  $A_2$  amplifiers into their common-mode input voltage range,  $(V-) + 1.5V$  to  $(V+) - 1.5V$ .

#### 6.3.4 Auxiliary Operational Amplifier

The LOG114 features two additional wide bandwidth amplifiers,  $A_4$  and  $A_5$ . These amplifiers are for use to support functions such as single-ended to differential conversion, or single-ended gain, scaling, offsetting, threshold detection, filtering, or other functions.

To verify op amp stability, an isolation resistor, or  $R_{iso}$  is sometimes needed especially when the op amp is driving capacitive loads. [Figure 6-1](#) is an example of what the isolation resistor architecture looks like.

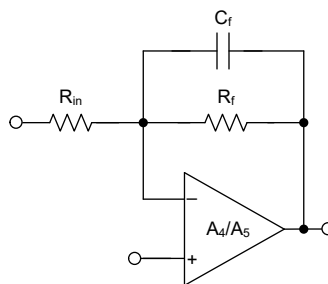


**Figure 6-1. Example of Isolation Resistor**

As shown in [Figure 5-17](#), for capacitive loads above 50pF, it is recommended to include an  $R_{iso}$  in the circuit to maintain at least 45° of phase margin.

Another cause of op amp instability can come from having large impedance feedback resistors. This instability results in the feedback resistor interacting with the internal input capacitors of the auxiliary amplifiers. There are two options to correcting this instability. The first one is lowering the resistor values in the feedback loop.

The second option, as shown in [Figure 6-2](#), is to put a feedback capacitor in the feedback loop in parallel with the feedback resistor.



**Figure 6-2. Example of Feedback Capacitor**

## 6.4 Device Functional Modes

The device has one mode of operation that applies when operated within the [Recommended Operating Conditions](#).

## 7 Application and Implementation

### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 7.1 Applications Information

#### 7.1.1 Transfer Function

The ideal transfer function of the LOG114 is:

$$V_{\text{LOGOUT}} = 0.375 \times \log\left(\frac{I_1}{I_2}\right) \quad (1)$$

This transfer function can be seen graphically in the typical characteristic curve, [Figure 5-6](#).

When a pedestal, or offset voltage ( $V_{\text{COM}}$ ) is connected to the COM pin, an additional offset term is introduced into the equation:

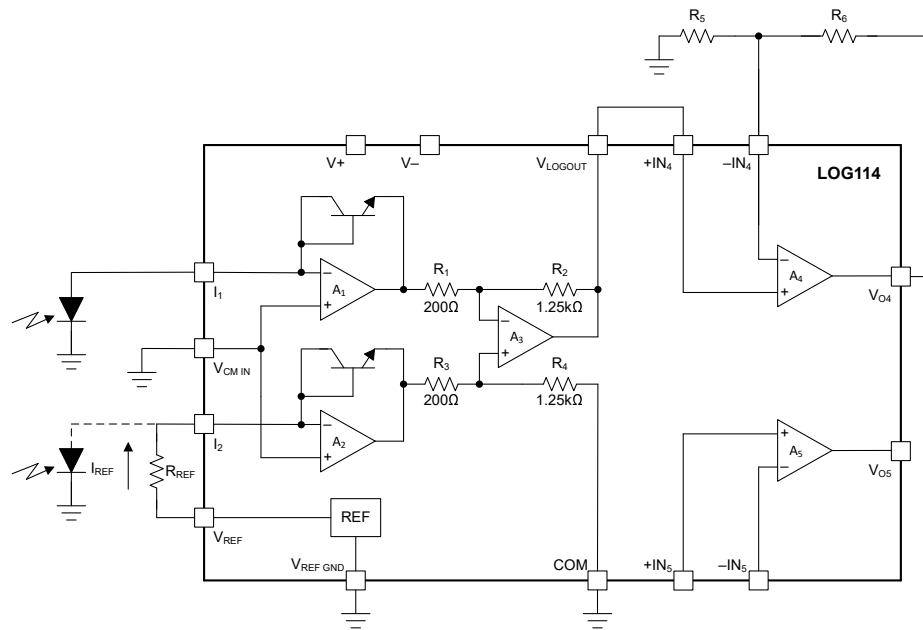
$$V_{\text{LOGOUT}} = 0.375 \times \log\left(\frac{I_1}{I_2}\right) + V_{\text{COM}} \quad (2)$$

#### 7.1.2 Input Current Range

To maintain specified accuracy, limit the input current range of the LOG114 from 100pA to 3.5mA. Input currents outside of this range can compromise the LOG114 performance. Input currents larger than 3.5mA result in increased nonlinearity. An absolute maximum input current rating of 10mA is included to prevent excessive power dissipation that can damage the input transistor.

#### 7.1.3 Setting the Reference Current

When the LOG114 is used to compute logarithms, either  $I_1$  or  $I_2$  can be held constant to become the reference current ( $I_{\text{REF}}$ ) to which the other is compared. As shown in [Figure 7-1](#),  $I_2$  is used as  $I_{\text{REF}}$  and is generated using the on-chip 2.5V  $V_{\text{REF}}$  pin.



**Figure 7-1. Example of Setting  $I_{REF}$**

It can be difficult to achieve an accurate  $I_{REF}$  at lower current values ( $<20\text{nA}$ ). Rather than choosing an  $I_{REF}$  value to be equal to  $I_{\text{SIGNAL}}(\text{min})$ , higher accuracy can be achieved by selecting  $I_{REF}$  to be in the center of the full signal range as shown in Equation 3.

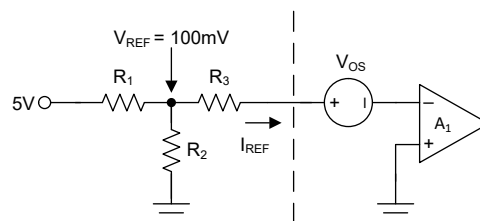
$$I_{REF} = I_{\text{SIGNAL}}(\text{min}) \times \sqrt{\frac{I_{\text{SIGNAL}}(\text{max})}{I_{\text{SIGNAL}}(\text{min})}} \quad (3)$$

For example, for a signal range of  $1\text{nA}$  to  $1\text{mA}$ , after plugging in the values into Equation 3,  $I_{REF} = 1\mu\text{A}$ . It is much easier and more precise (that is, DC accuracy, temperature stability, and lower noise) to establish a  $1\mu\text{A}$  DC current level than a  $1\text{nA}$  level for the reference current.

The reference current may be derived from a voltage source with one or more resistors. When a single resistor is used, the value may be large depending on  $I_{REF}$ . If  $I_{REF}$  is  $10\text{nA}$  and  $2.5\text{V}$  is used:

$$R_{REF} = \frac{V_{\text{SOURCE}}}{I_{REF}} = \frac{2.5\text{V}}{10\text{nA}} = 250\text{M}\Omega \quad (4)$$

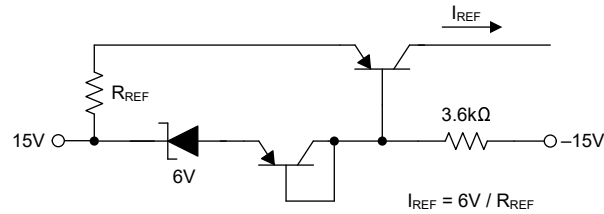
A voltage divider T-Network circuit can be used to reduce the value of the resistor, as shown in Figure 7-2. When using this method, consider the possible errors caused by the amplifier input offset voltage. The input offset voltage of amplifier  $A_1$  has a maximum value of  $4\text{mV}$  in a  $\pm 5\text{V}$  supply system, and a maximum value of  $7\text{mV}$  in a  $5\text{V}$  supply system. Consider resistor temperature stability and noise contributions, as well.



**Figure 7-2. T-Network for Reference Current**

$V_{REF}$  may be an external precision voltage reference, or the on-chip  $2.5\text{V}$  voltage reference of the LOG114.

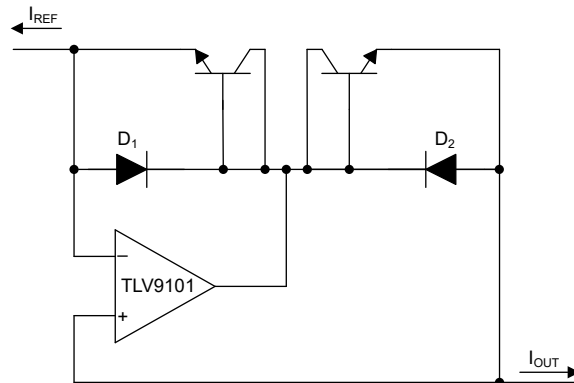
$I_{REF}$  can be derived from an external current source, such as that shown in Figure 7-3.



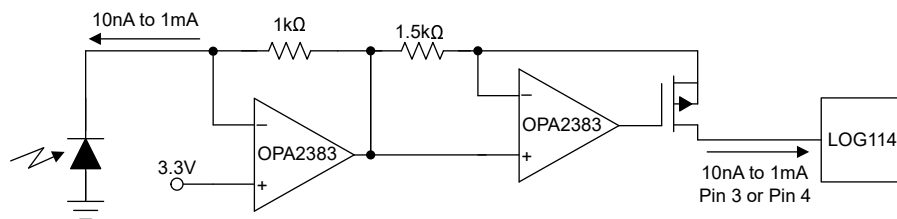
**Figure 7-3. Temperature-Compensated Current Source**

#### 7.1.4 Negative Input Currents

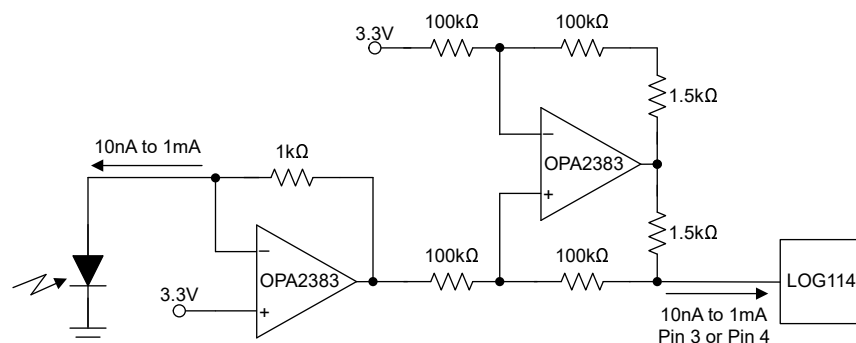
The LOG114 functions only with positive input currents (conventional current flows into input current pins). In situations where negative input currents are needed, the example circuits in [Figure 7-4](#), [Figure 7-5](#), and [Figure 7-6](#) can be referenced.



**Figure 7-4. Current Inverter/Current Source**



**Figure 7-5. Precision Current Inverter/Current Source**



**Figure 7-6. Precision Current Inverter/Current Source**

#### 7.1.5 Voltage Inputs

The LOG114 was optimized for current inputs. Voltage inputs may be handled directly by using a low-impedance voltage source with series resistors, but the dynamic input range is limited to approximately three decades

### 7.1.6 High-Current Linearity Correction

$$V_{\text{LOGOUT}} = 0.375 \times \log\left(\frac{I_1}{I_2}\right) + I_1 \times R_S + 2 \quad (5)$$

### Figure 7-7. High-Current Linearity Correction Circuit

### 7.1.7 Error Sources

#### 7.1.7.1 Accuracy

### 7.1.7.2 Total Error

$$V_{\text{LOGOUT (actual)}} = V_{\text{LOGOUT (ideal)}} \pm \text{Total\_Error} \quad (6)$$

[Equation 6](#) represents the sum of all the individual components of error normally associated with the log amp when operating in the current input mode. The worst-case error for any given ratio of  $I_1/I_2$  is the largest of the two errors when  $I_1$  and  $I_2$  are considered separately. Temperature can also affect total error.

#### 7.1.7.3 Errors RTO and RTI

As with any transfer function, errors generated by the function may be Referred-to-Output (RTO) or Referred-to-Input (RTI). Log amps have a unique property that the error voltage at the output corresponds to a constant percentage of the input, regardless of the actual input level.

#### 7.1.7.4 Log Conformity

For the LOG114, log conformity is calculated in the same way as linearity and is plotted as  $I_1/I_2$  on a semilog scale. In many applications, log conformity is the most important specification. This condition is true because bias current errors are negligible (5pA for the LOG114), and the scale factor and offset errors may be trimmed to zero or removed by system calibration. These factors leave log conformity as the major source of error.

Log conformity is defined as the peak deviation from the best fit straight line of the  $V_{\text{LOGOUT}}$  versus  $\log(I_1/I_2)$  curve. Log conformity is then expressed as a percent of ideal full-scale output. Thus, the nonlinearity error expressed in volts over  $m$  decades is:

$$V_{\text{LOGOUT (nonlinear)}} = 0.375 \frac{V}{\text{decade}} \times 2Nm \quad (7)$$

where

- $N$  is the log conformity error, in percent

#### 7.1.7.5 Individual Error Components

The ideal transfer function with current input is:

$$V_{\text{LOGOUT (IDEAL)}} = 0.375 \times \log\left(\frac{I_1}{I_2}\right) \quad (8)$$

The actual transfer function with the major components of error is:

$$V_{\text{LOGOUT (actual)}} = 0.375 \times \left(1 \pm \Delta K\right) \times \log\left(\frac{I_1}{I_2}\right) \pm 2Nm \pm V_{\text{OSO}} \quad (9)$$

where:

- $\Delta K$  = gain error (0.4%, typical, as specified in the [Electrical Characteristics](#) table)
- $I_{B1}$  = bias current of  $A_1$  (5pA, typical)
- $I_{B2}$  = bias current of  $A_2$  (5pA, typical)
- $m$  = number of decades over which the log conformity error is specified
- $N$  = log conformity error (0.1%, typical for  $m = 5$  decades; 0.9% typical for  $m = 7.5$  decades)
- $V_{\text{OSO}}$  = output offset voltage (11mV, typical for  $\pm 5V$  supplies; 14mV, typical for +5V supplies)

To determine the typical error resulting from these error components, first compute the ideal output. Then calculate the output again, this time including the individual error components. Then use [Equation 10](#) to determine the error in percent:

$$\% \text{ error} = \left| \frac{V_{\text{LOGOUT (ideal)}} - V_{\text{LOGOUT (typical)}}}{V_{\text{LOGOUT (ideal)}}} \right| \times 100 \% \quad (10)$$

For example, in a system configured for measurement of five decades, with  $I_1 = 1\text{mA}$ , and  $I_2 = 10\mu\text{A}$ :

$$V_{\text{LOGOUT (ideal)}} = 0.375 \times \log\left(\frac{10^{-3}}{10^{-5}}\right) = 0.75V \quad (11)$$

$$V_{\text{LOGOUT (typical)}} = 0.375 \left( 1 \pm 0.004 \right) \times \log \left( \frac{10^{-3} - 5 \times 10^{-12}}{10^{-5} - 5 \times 10^{-12}} \right) \pm 2 \left( 0.001 \right) \left( 5 \right) \pm 0.011 \quad (12)$$

Using the positive error components (+ΔK, +2Nm, and +V<sub>OSO</sub>) to calculate the maximum typical output:

$$V_{\text{LOGOUT (typical)}} = 0.774V \quad (13)$$

Therefore, the error in percent is:

$$\% \text{ error} = \left| \frac{0.75 - 0.774}{0.75} \right| \times 100 \% = 3.2 \% \quad (14)$$

## 7.2 Typical Applications

### 7.2.1 Design Example for Dual-Supply Configuration

Given these conditions:

**Table 7-1. Example Design Parameters for Dual-Supply Parameters**

| Parameter               | Example Value |
|-------------------------|---------------|
| Positive supply voltage | 5V            |
| Negative supply voltage | -5V           |
| Input signal            | 100pA to 10mA |
| Reference voltage       | 2.5V          |
| Output voltage          | 0V to 2.5V    |

1. Due to LOG114 symmetry, choose either  $I_1$  or  $I_2$  as the signal input pin. Choosing  $I_1$  as the reference makes the resistor network around  $A_4$  simpler. (Note: Current must flow into  $I_1$  and  $I_2$  pins.)
2. Select the magnitude of the reference current. The signal ( $I_2$ ) spans eight decades, therefore set  $I_1$  to  $1\mu\text{A}$  – four decades above the minimum  $I_2$  value. (Note that the value does not have to be placed in the middle. If  $I_2$  spanned seven decades,  $I_1$  can set three decades above the minimum and four decades below the maximum  $I_2$  value.) This configuration results in more swing amplitude in the negative direction, which provides more sensitivity ( $\Delta V_{O4}$  per  $\Delta I_2$ ) when the current signal decreases.
3. Use [Equation 1](#) to calculate the expected range of log outputs at  $V_{\text{LOGOUT}}$ :

For  $I_2 = 10\text{mA}$ : (15)

$$V_{\text{LOGOUT}} = 0.375 \times \log\left(\frac{1\mu\text{A}}{10\text{mA}}\right) = -1.5\text{V} \quad \text{For } I_2 = 100\text{pA:}$$

$$V_{\text{LOGOUT}} = 0.375 \times \log\left(\frac{1\mu\text{A}}{100\text{pA}}\right) = 1.5\text{V}$$

Therefore, the expected voltage range at the output of amplifier  $A_3$  is:

$$-1.5\text{V} \leq V_{\text{LOGOUT}} \leq 1.5\text{V} \quad (16)$$

4. The  $A_4$  amplifier scales and offsets the  $V_{\text{LOGOUT}}$  signal for use by the ADC using the equation:

$$V_{O4} = (-G_{A4} \times V_{\text{LOGOUT}}) + V_{\text{OFFSET}} \quad (17)$$

The  $A_4$  amplifier is specified with a rated output swing capability from  $(V-) + 0.5\text{V}$  to  $(V+) - 0.5\text{V}$ .

Therefore, choose the final  $A_4$  output:

$$0\text{V} \leq V_{O4} \leq 2.5\text{V} \quad (18)$$

This output results in a 2.5V range for the 3V  $V_{\text{LOGOUT}}$  range, therefore a gain of 5/6 is needed for  $A_4$ .

5. When  $I_2 = 10\text{mA}$ ,  $V_{\text{LOGOUT}} = -1.5\text{V}$ . Using [Equation 19](#) in step 4:

$$0\text{V} = \frac{-2.5\text{V}}{3\text{V}} \times (-1.5\text{V}) + V_{\text{OFFSET}} \quad (19)$$

Therefore,  $V_{\text{OFFSET}} = 1.25\text{V}$

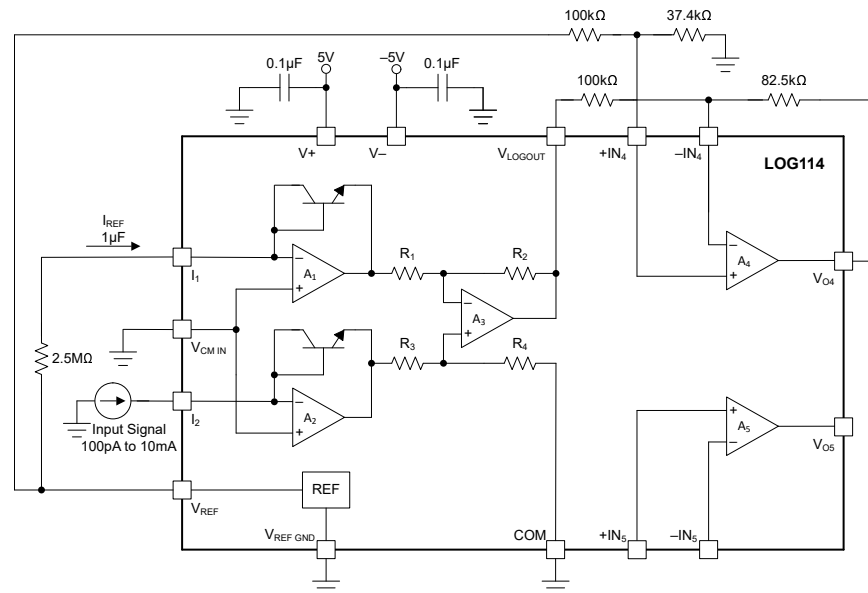
This makes the  $A_4$  formula:

$$V_{O4} = \frac{-5}{6}(V_{\text{LOGOUT}}) + 1.25 \quad (20)$$

Replacing  $V_{\text{LOGOUT}}$  with [Equation 1](#) gives the system's overall function to be:

$$V_{O4} = -0.347 \times \log\left(\frac{I_1}{I_2}\right) + 1.25V \quad (21)$$

The external resistor values for A<sub>4</sub> can be seen in Figure 7-8.



**Figure 7-8. Dual Supply Configuration Example for Best Accuracy Over Eight Decades**

### 7.2.2 Design Example for Single-Supply Configuration

Given these conditions:

**Table 7-2. Example Design Parameters for Single-Supply Parameters**

| Parameter               | Example Value |
|-------------------------|---------------|
| Positive supply voltage | 5V            |
| Negative supply voltage | 0V            |
| Input signal            | 100pA to 10mA |
| Reference voltage       | 2.5V          |
| Output voltage          | 0.5V to 2.5V  |

- Choose either I<sub>1</sub> or I<sub>2</sub> as the signal input pin. For this example, I<sub>2</sub> is used. Choosing I<sub>1</sub> as the reference current makes the resistor network around A<sub>4</sub> simpler. (Note: Current only flows into the I<sub>1</sub> and I<sub>2</sub> pins.)
- Select the magnitude of the reference current. Since the signal (I<sub>2</sub>) spans eight decades, set I<sub>1</sub> to 1µA – four decades above the minimum I<sub>2</sub> value, and four decades below the maximum I<sub>2</sub> value. (Note that the value does not have to be placed in the middle. If I<sub>2</sub> spanned seven decades, I<sub>1</sub> can set three decades above the minimum and four decades below the maximum I<sub>2</sub> value.) This configuration results in more swing amplitude in the negative direction, which provides more sensitivity (ΔV<sub>O4</sub> per ΔI<sub>2</sub>) when the current signal decreases.
- Use Equation 1 to calculate the expected range of log outputs at V<sub>LOGOUT</sub>:

For I<sub>2</sub> = 10mA: (22)

$$V_{\text{LOGOUT}} = 0.375 \times \log\left(\frac{1\mu\text{A}}{10\text{mA}}\right) = -1.5V \quad \text{For } I_2 = 100\text{pA: } V_{\text{LOGOUT}} = 0.375 \times \log\left(\frac{1\mu\text{A}}{100\text{pA}}\right) = 1.5V$$

Therefore, the expected voltage range at the output of amplifier A<sub>3</sub> is:

$$-1.5V \leq V_{\text{LOGOUT}} \leq 1.5V \quad (23)$$

This result is acceptable in a dual-supply system ( $V^+ = 5V$ ,  $V^- = -5V$ ) where the output can swing below ground, but this result does not work in a single supply 5V system. Therefore, an offset voltage must be added to the system.

4. Select an offset voltage,  $V_{COM}$  to use for centering the output between  $(V^-) + 0.6V$  and  $(V^+) - 0.6V$ , which is the full-scale output capability of the  $A_3$  amplifier. Choosing  $V_{COM} = 2.5V$ , and recalculating the expected voltage output range for  $V_{LOGOUT}$  using Equation 2, results in:

$$1V \leq V_{LOGOUT} \leq 4V \quad (24)$$

5. The  $A_4$  amplifier scales and offsets the  $V_{LOGOUT}$  signal for use by the ADC using the equation:

$$V_{O4} = -G_{A4} \times V_{LOGOUT} + V_{OFFSET} \quad (25)$$

The  $A_4$  amplifier is specified with a rated output swing capability from  $(V^-) + 0.5V$  to  $(V^+) - 0.5V$ .

Therefore, choose the final  $A_4$  output:

$$0.5V \leq V_{O4} \leq 2.5V \quad (26)$$

This output results in a 2V range for the 3V  $V_{LOGOUT}$  range, therefore a gain of 2/3 is needed for  $A_4$ .

6. When  $I_2 = 10mA$ ,  $V_{LOGOUT} = 1V$ , and  $V_{O4} = 2.5V$ . Using Equation 25 in step 5:

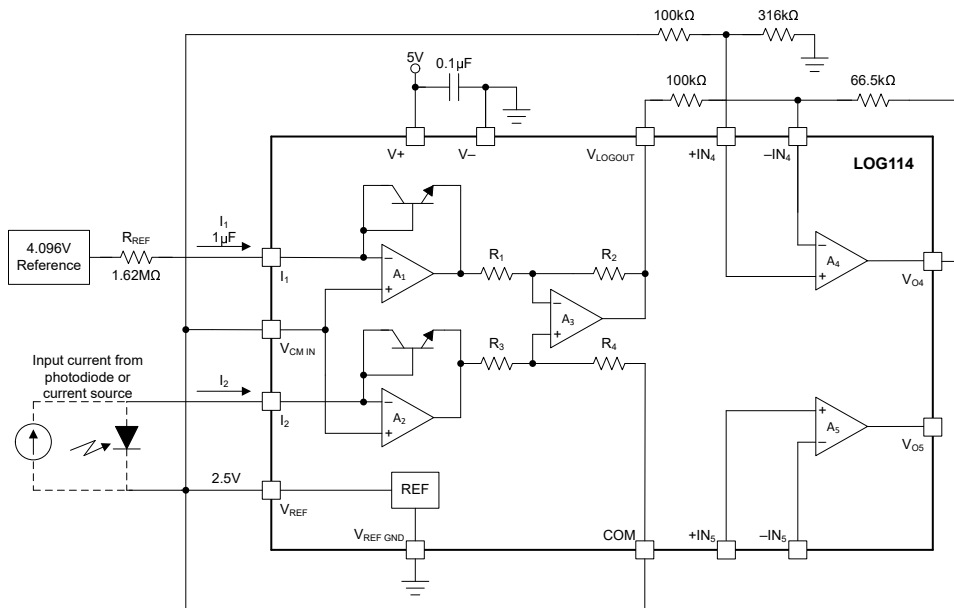
$$2.5V = \frac{-2V}{3V} \times (1V) + V_{OFFSET} \quad (27)$$

Therefore,  $V_{OFFSET} = 3.17V$

The  $A_4$  amplifier configuration for  $V_{O4} = -2/3(V_{LOGOUT}) + 3.17$  is seen in Figure 7-10.

The overall transfer function is:

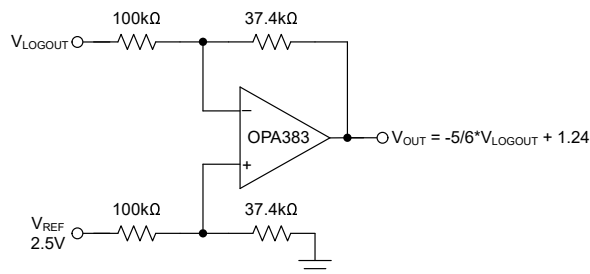
$$V_{O4} = -0.25 \times \log\left(\frac{I_1}{I_2}\right) + 1.5V \quad (28)$$



- A. In single-supply configuration,  $V_{CM IN}$  must be connected to  $\geq 1V$ .
- B. The cathode of the photodiode is returned to  $V_{REF}$  resulting in zero bias across the photodiode. The cathode can be returned to a voltage more positive than  $V_{CM IN}$  to create a reverse bias for reducing photodiode capacitance, which increases speed.

**Figure 7-9. Single-Supply Configuration Example for Measurement Over Eight Decades**

A similar process can be used to configure an external rail-to-rail output op amp, such as the OPA383. The OPA383 op amp can swing down to almost 0V (for details, refer to the [OPA383 data sheet](#)), therefore the scaling factor can be approximated to be 2.5/3 and the corresponding  $V_{\text{OFFSET}}$  is 1.24V. Figure 7-10 shows this circuit configuration.



**Figure 7-10. Operational Amplifier Configuration for Scaling and Offsetting the Output Going to ADC Stage**

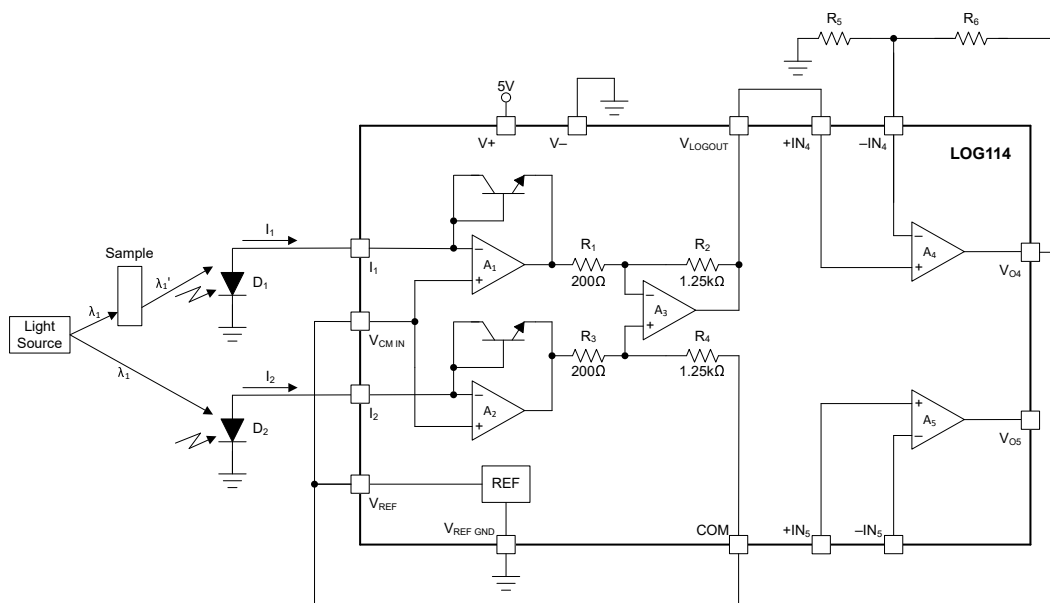
### 7.2.3 Advantages of Dual-Supply Operation

The LOG114 performs well on a single 5V supply by level-shifting COM pin to half-supply and raising the common-mode voltage ( $V_{\text{CM IN}}$  pin) of the input amplifiers. This level-shift places the input amplifiers in the linear operating range. However, there are also some advantages to operating the LOG114 on dual  $\pm 5\text{V}$  supplies. These advantages include:

1. Eliminating the need for the 4.096V precision reference
2. Eliminating a small additional source of error arising from the noise and temperature drift of the level-shifting voltage
3. Allowing increased magnitude of a reverse bias voltage on the photodiode

### 7.2.4 Log Ratio

One of the more common uses of log ratio amplifiers is to measure absorbance. See Figure 7-11 for a typical application. Absorbance of the sample is  $A = \log \lambda_1' / \lambda_1$ . If  $D_1$  and  $D_2$  are matched,  $A \propto (0.375\text{V}) \log(I_1/I_2)$ .



- A.  $V_{\text{LOGOUT}} = 0.375 \times \log(I_1/I_2)$ .  
B.  $V_{O4} = 0.375 \times K \times \log(I_1/I_2)$ ,  $K = 1 + R_6/R_5$ .

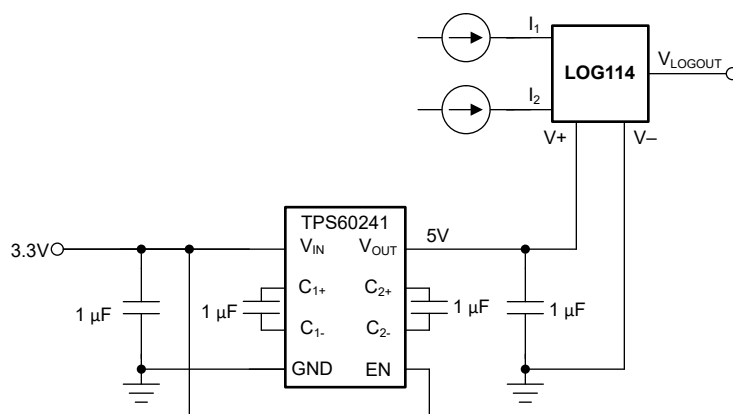
**Figure 7-11. Using the LOG114 to Measure Absorbance**

### 7.2.5 Data Compression

In many applications, the compressive effects of the logarithmic transfer function are useful. For example, a LOG114 preceding a 12-bit ADC can produce the dynamic range equivalent to a 20-bit converter (like the ADS7818 or ADS7834).

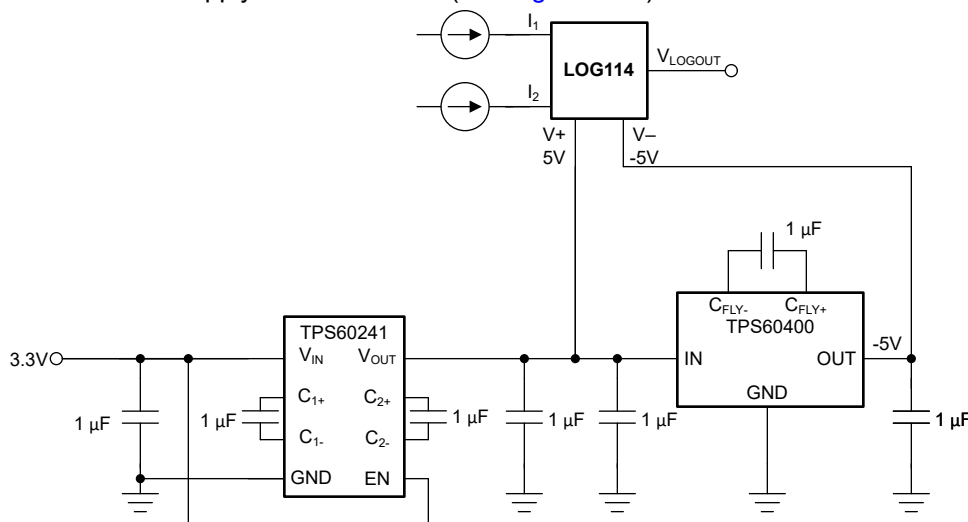
### 7.2.6 3.3V Operation

For systems with only a 3.3V power supply, the TPS60241 zero-ripple switched cap buck-boost 2.7V to 5.5V input to 5V output converter may be used to generate a 5V supply for the LOG114 (see [Figure 7-12](#)).



**Figure 7-12. Creating a 5V Supply from a 3.3V Supply**

Likewise, the TPS6040 negative charge pump may be connected to the 5V output of the TPS60241 to generate a -5V supply to create a  $\pm 5V$  supply for the LOG114 (see [Figure 7-13](#)).



**Figure 7-13. Creating a  $\pm 5V$  Supply from a 3.3V Supply**

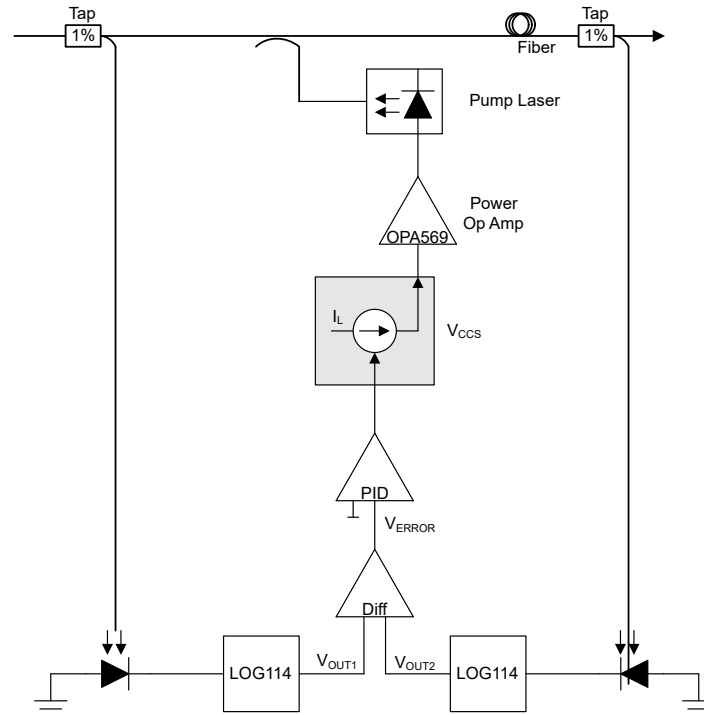
### 7.2.7 Erbium-Doped Fiber Optic Amplifier (EDFA)

The LOG114 was designed for optical networking systems. [Figure 7-14](#) shows a block diagram of the LOG114 in a typical EDFA application. This application uses two log amps to measure the optical input and output power of the amplifier. A difference amplifier subtracts the log output signals of both log amps and applies an error voltage to the proportional-integral-derivative (PID) controller. The controller output adjusts a voltage-controlled current source ( $V_{CCS}$ ), which then drives the power op amp and pump laser. The desired optical gain is achieved when the error voltage at the PID is zero.

The log ratio function is the optical power gain of the EDFA. This circuitry forms an automatic power level control loop.

An alternate design of the system shown in [Figure 7-14](#) is possible because the LOG114 inherently takes the log ratio. Therefore, one log amp can be eliminated by connecting one of the photodiodes to the LOG114  $I_1$  input, and the other to the  $I_2$  input. The differential amplifier can then be eliminated.

The fast rise and fall times of the LOG114 are designed for most EDFA applications (typically less than  $1\mu\text{s}$  for a 100:1 current input step). The device also measures a very wide dynamic range of up to eight decades.



**Figure 7-14. Erbium-Doped Fiber Optic Amplifier (EDFA) Block Diagram**

## 7.3 Power Supply Recommendations

To reduce the influence of lead inductance of power-supply lines, TI recommends that each supply be bypassed with a 0.1 $\mu$ F ceramic capacitor. Connect these capacitors as close to the LOG114 supply pins to ground as possible to improve supply-related noise rejection. A single bypass capacitor from V+ to ground is applicable for single-supply applications.

## 7.4 Layout

### 7.4.1 Layout Guidelines

Attention to good layout practices is always recommended. For best operational performance of the device, use good printed circuit board (PCB) layout practices, including:

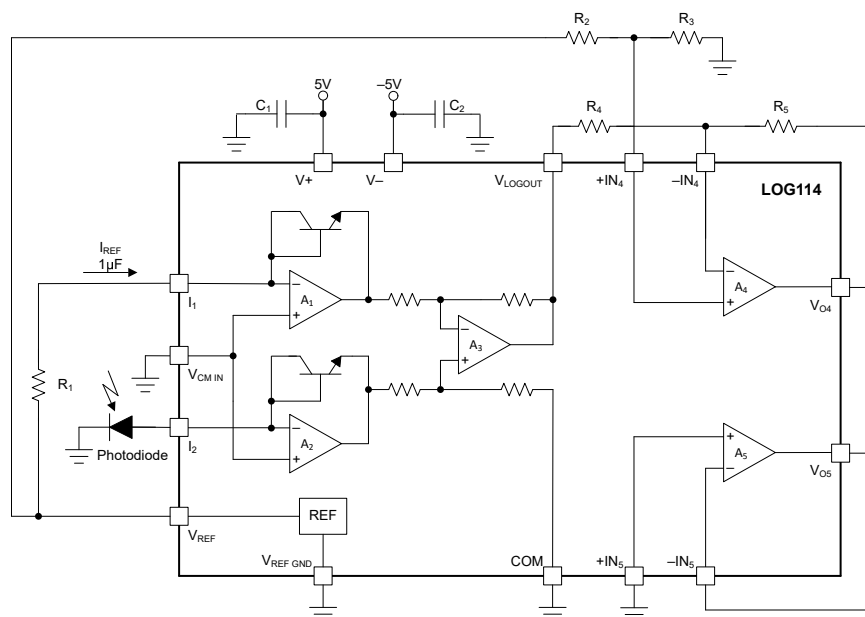
- Make sure that both input paths of the secondary amplifier are symmetrical and well-matched for source impedance and capacitance to avoid converting common-mode signals into differential signals and thermal electromotive forces (EMFs).
- Noise can propagate into analog circuitry through the power pins of the device and of the circuit as a whole. Bypass capacitors reduce the coupled noise by providing low-impedance power sources local to the analog circuitry. Connect low-ESR, 0.1 $\mu$ F X7R ceramic bypass capacitors between each supply pin and ground, placed as close as possible to the device. A single bypass capacitor from V+ to ground is applicable for single-supply applications.
- Use a C0G (NP0) ceramic capacitor for the VCM decoupling capacitance and place as close to the VCM pin as possible.
- For photoelectric-sensing applications, place the photodiode as close as possible to the I<sub>1</sub> pin to minimize parasitic inductance.
- To reduce parasitic coupling, run the input traces as far away as possible from the supply or output traces. If these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better than in parallel with the noisy trace.
- Minimize the number of thermal junctions. Preferably, the signal path is routed within a single layer without vias, with the traces as short as possible.
- Keep sufficient distance from major thermal energy sources (circuits with high power dissipation). If not possible, place the device so that the effects of the thermal energy source on the high and low sides of the differential signal path are evenly matched.
- Solder the thermal pad to the PCB. For the LOG114 to properly dissipate heat and minimize leakage, connect the thermal pad to a plane or large copper pour that is electrically connected to V–, even for low-power applications.
  - The exposed pad must be soldered to the PCB to provide structural integrity and long-term reliability.

The LOG114 comes in a QFN-16 package. This leadless package has lead contacts on all four sides of the bottom of the package, thereby maximizing board space. An exposed leadframe die pad on the bottom of the package enhances thermal and electrical characteristics.

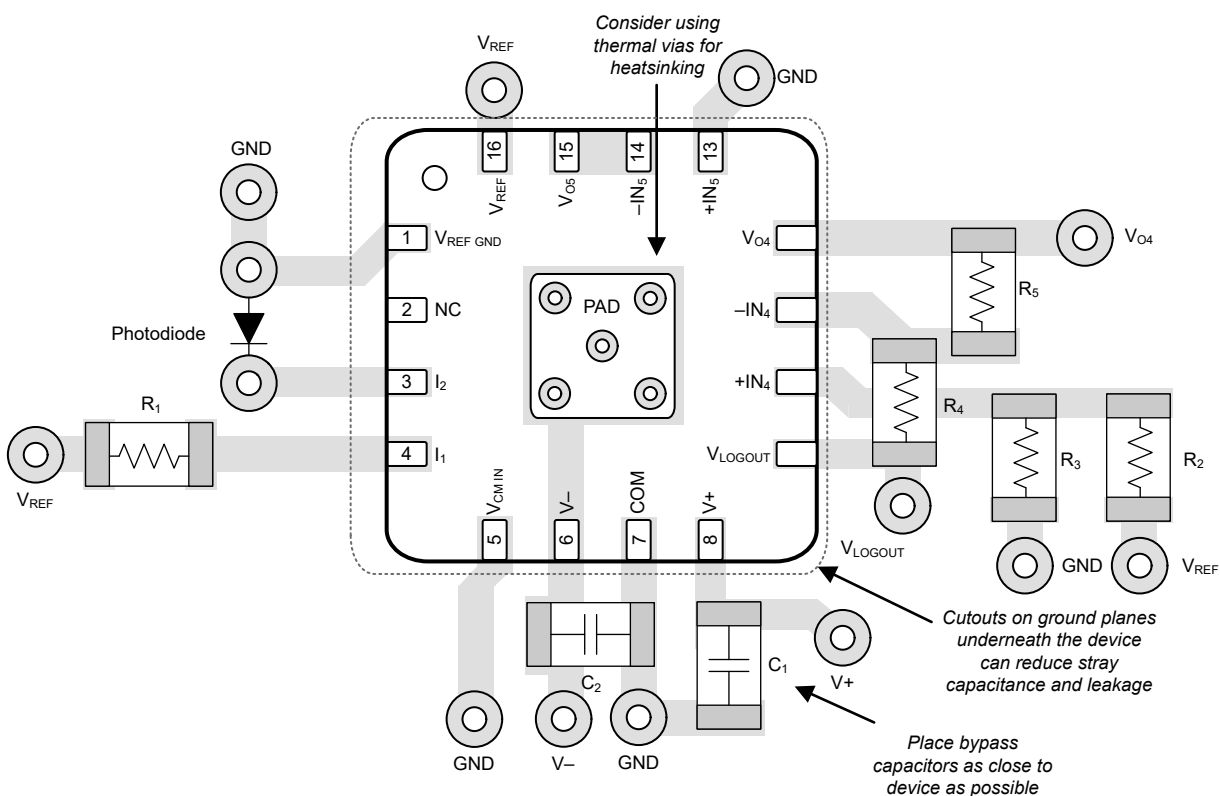
QFN packages are physically small, have a smaller routing area, improved thermal performance, and improved electrical parasitics. Additionally, the absence of external leads eliminates bent-lead issues.

The QFN package can be easily mounted using standard printed circuit board (PCB) assembly techniques. See also [QFN and SON PCB Attachment application note](#) and [Quad Flatpack No-Lead Logic Packages application note](#).

### 7.4.2 Layout Example



**Figure 7-15. LOG114 Example Circuit**



**Figure 7-16. LOG114 Layout Example**

## 8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

### 8.1 Documentation Support

For development support on this product see the following:

#### 8.1.1 Related Documentation

- Texas Instruments, [QFN and SON PCB Attachment application note](#)
- Texas Instruments, [Quad Flatpack No-Lead Logic Packages application note](#)

#### 8.1.2 PSpice® for TI

PSpice® for TI is a design and simulation environment that helps evaluate performance of analog circuits. Create subsystem designs and prototype solutions before committing to layout and fabrication, reducing development cost and time to market.

#### 8.1.3 TINA-TI™ (Free Software Download)

TINA™ is a simple, powerful, and easy-to-use circuit simulation program based on a SPICE engine. TINA-TI is a free, fully-functional version of the TINA software, preloaded with a library of macro models in addition to a range of both passive and active models. TINA-TI provides all the conventional dc, transient, and frequency domain analysis of SPICE, as well as additional design capabilities.

Available as a [free download](#) from the Analog eLab Design Center, TINA-TI offers extensive post-processing capability that allows users to format results in a variety of ways. Virtual instruments offer the ability to select input waveforms and probe circuit nodes, voltages, and waveforms, creating a dynamic quick-start tool.

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#### Note

These files require that either the TINA software (from DesignSoft™) or TINA-TI software be installed. Download the free TINA-TI software from the [TINA-TI folder](#).

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### 8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](#). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 8.3 Support Resources

TI E2E™ [support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### 8.4 Trademarks

DesignSoft™ is a trademark of DesignSoft, Inc.

TI E2E™ is a trademark of Texas Instruments.

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### 8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 8.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Revision A (March 2007) to Revision B (March 2025)                                                                                                                                                                                                                                       | Page |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|
| • Added the <i>Pin Configuration, Specifications, ESD Ratings, Recommended Operating Conditions, Thermal Information, Detailed Description, Typical Applications, Layout, Layout Guidelines, Device and Documentation Support, and Mechanical, Packaging, and Orderable Information</i> sections..... | 1    |
| • Updated the numbering format for tables, figures, and cross-references throughout the document.....                                                                                                                                                                                                 | 1    |
| • Added <i>Pin Functions</i> table.....                                                                                                                                                                                                                                                               | 3    |
| • Added the CDM ESD rating.....                                                                                                                                                                                                                                                                       | 4    |
| • Moved ESD rating from <i>Absolute Maximum Ratings</i> to <i>ESD Rating</i> .....                                                                                                                                                                                                                    | 4    |
| • Moved specified temperature and power-supply parameters from <i>Electrical Characteristics</i> to <i>Recommended Operating Conditions</i> .....                                                                                                                                                     | 4    |
| • Deleted thermal resistance, $\theta_{JA}$ parameters in <i>Electrical Characteristics</i> and replaced with detailed thermal model parameters in <i>Thermal Information</i> .....                                                                                                                   | 4    |
| • Updated formatting of <i>Electrical Characteristics</i> table.....                                                                                                                                                                                                                                  | 5    |
| • Changed logarithmic conformity error 1nA to 100 $\mu$ A (5 decades) maximum spec from 0.2% to 0.3% (0.017dB to 0.026dB) in <i>Electrical Characteristics</i> .....                                                                                                                                  | 5    |
| • Changed logarithmic conformity error 100pA to 3.5A (7.5 decades) typical spec from 0.9% to 2.2% (0.08dB to 0.19dB) in <i>Electrical Characteristics</i> .....                                                                                                                                       | 5    |
| • Changed logarithmic conformity error 100pA to 3.5mA (7.5 decades) (-5°C to 75°C) typical spec from 0.5% to 2.3% in <i>Electrical Characteristics</i> .....                                                                                                                                          | 5    |
| • Added test condition to current noise $i_n$ in <i>Electrical Characteristics</i> .....                                                                                                                                                                                                              | 5    |
| • Consolidated BW (10 $\mu$ A to 1mA (ratio 1:100), 1mA to 3.5mA (ratio 1:3.5), and 3.5mA to 10mA (ratio 1:2.9)) into 10 $\mu$ A to 10mA (1:1k) in <i>Electrical Characteristics</i> .....                                                                                                            | 5    |
| • Deleted 10nA to 10 $\mu$ A (ratio 1:1k) and 10nA to 1mA (ratio 1:100k) step response specifications in <i>Electrical Characteristics</i> .....                                                                                                                                                      | 5    |
| • Changed step response 8nA to 240nA (Increasing) from 0.7 $\mu$ s to 0.8 $\mu$ s in <i>Electrical Characteristics</i> .....                                                                                                                                                                          | 5    |
| • Changed step response 8nA to 240nA (Decreasing) from 1 $\mu$ s to 6 $\mu$ s in <i>Electrical Characteristics</i> .....                                                                                                                                                                              | 5    |
| • Changed step response 10nA to 1 $\mu$ A (Increasing) from 0.15 $\mu$ s to 0.25 $\mu$ s in <i>Electrical Characteristics</i> .....                                                                                                                                                                   | 5    |
| • Changed step response 10nA to 1 $\mu$ A (Decreasing) from 0.25 $\mu$ s to 4 $\mu$ s in <i>Electrical Characteristics</i> .....                                                                                                                                                                      | 5    |
| • Changed logarithmic conformity error 1nA to 100 $\mu$ A (5 decades) maximum spec from 0.25% to 0.3% (0.022dB to 0.026dB) in <i>Electrical Characteristics</i> .....                                                                                                                                 | 7    |
| • Changed logarithmic conformity error 100pA to 3.5A (7.5 decades) typical spec from 0.9% to 2.2% (0.08dB to 0.19dB) in <i>Electrical Characteristics</i> .....                                                                                                                                       | 7    |
| • Changed logarithmic conformity error 100pA to 3.5A (7.5 decades) (-5°C to 75°C) typical spec from 0.5% to 2.3% in <i>Electrical Characteristics</i> .....                                                                                                                                           | 7    |
| • Changed scaling factor error from 0.035dB to 0.035dB in <i>Electrical Characteristics</i> .....                                                                                                                                                                                                     | 7    |
| • Changed scaling factor error from 0.035% to 1.5% in <i>Electrical Characteristics</i> .....                                                                                                                                                                                                         | 7    |
| • Added test condition to current noise $i_n$ in <i>Electrical Characteristics</i> .....                                                                                                                                                                                                              | 7    |
| • Consolidated BW (10 $\mu$ A to 1mA (ratio 1:100), 1mA to 3.5mA (ratio 1:3.5), and 3.5mA to 10mA (ratio 1:2.9)) into 10 $\mu$ A to 10mA (1:1k) in <i>Electrical Characteristics</i> .....                                                                                                            | 7    |
| • Deleted 10nA to 10 $\mu$ A (ratio 1:1k) and 10nA to 1mA (ratio 1:100k) step response specifications in <i>Electrical Characteristics</i> .....                                                                                                                                                      | 7    |
| • Changed step response 8nA to 240nA (Increasing) from 0.7 $\mu$ s to 0.8 $\mu$ s in <i>Electrical Characteristics</i> .....                                                                                                                                                                          | 7    |
| • Changed step response 8nA to 240nA (Decreasing) from 1 $\mu$ s to 6 $\mu$ s in <i>Electrical Characteristics</i> .....                                                                                                                                                                              | 7    |
| • Changed step response 10nA to 100nA (Decreasing) from 2 $\mu$ s to 5 $\mu$ s in <i>Electrical Characteristics</i> .....                                                                                                                                                                             | 7    |
| • Changed step response 10nA to 1 $\mu$ A (Increasing) from 0.15 $\mu$ s to 0.25 $\mu$ s in <i>Electrical Characteristics</i> .....                                                                                                                                                                   | 7    |
| • Changed step response 10nA to 1 $\mu$ A (Decreasing) from 0.25 $\mu$ s to 4 $\mu$ s in <i>Electrical Characteristics</i> .....                                                                                                                                                                      | 7    |

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|                                                                                                                                                                                                                                             |    |
|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----|
| • Changed typical graphs: $A_4$ and $A_5$ Gain and Phase vs Frequency, $A_4$ and $A_5$ Noninverting Closed-Loop Response, $A_4$ and $A_5$ Inverting Closed-Loop Response, $A_4$ and $A_5$ Capacitive Load Response .....                    | 9  |
| • Removed typical characteristics graphs: Log Conformity vs Temperature, 4 Decade Log Conformity vs $I_{REF}$ , 5 Decade Log Conformity vs $I_{REF}$ , 6 Decade Log Conformity vs $I_{REF}$ , and 8 Decade Log Conformity vs $I_{REF}$ .... | 9  |
| • Added Auxiliary Operational Amplifier section.....                                                                                                                                                                                        | 12 |
| • Removed suggested transistors in Example of Setting $I_{REF}$ figure.....                                                                                                                                                                 | 14 |
| • Changed the suggested op amps, transistors, and diodes in the Negative Input Currents section.....                                                                                                                                        | 16 |
| • Added High-Current Linearity Correction section.....                                                                                                                                                                                      | 17 |
| • Changed the equations in the Design Example for Dual-Supply Configuration section.....                                                                                                                                                    | 20 |
| • Changed Operational Amplifier Configuration for Scaling and Offsetting the Output Going to ADC Stage figure.....                                                                                                                          | 21 |

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## 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable part number        | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|------------------------------|---------------|----------------------|-----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">LOG114AIRGVR</a> | Active        | Production           | VQFN (RGV)   16 | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | 0 to 70      | LOG<br>114          |
| LOG114AIRGVR.A               | Active        | Production           | VQFN (RGV)   16 | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | 0 to 70      | LOG<br>114          |
| LOG114AIRGVR.B               | Active        | Production           | VQFN (RGV)   16 | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | 0 to 70      | LOG<br>114          |
| <a href="#">LOG114AIRGVT</a> | Active        | Production           | VQFN (RGV)   16 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | 0 to 70      | LOG<br>114          |
| LOG114AIRGVT.A               | Active        | Production           | VQFN (RGV)   16 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | 0 to 70      | LOG<br>114          |
| LOG114AIRGVT.B               | Active        | Production           | VQFN (RGV)   16 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | 0 to 70      | LOG<br>114          |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

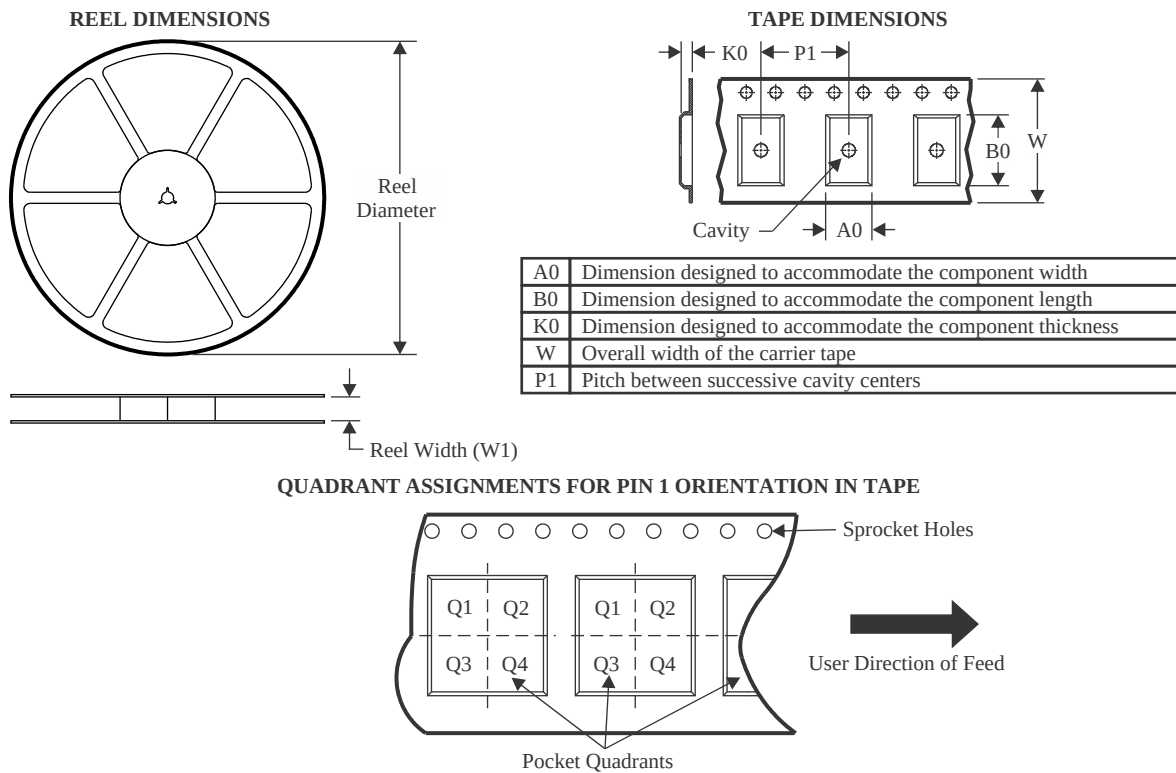
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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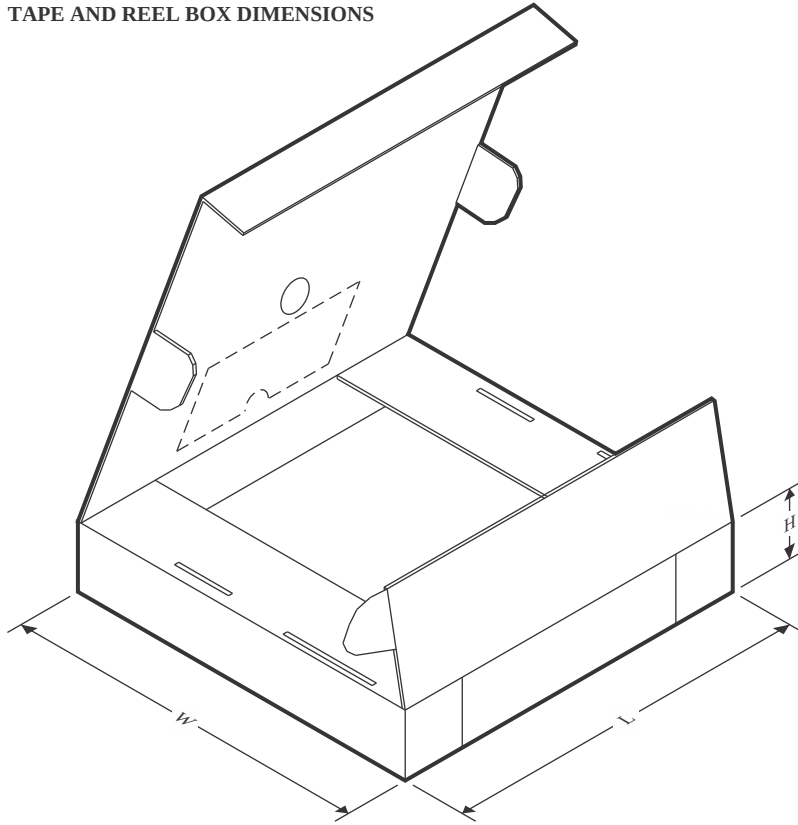
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| LOG114AIRGVR | VQFN         | RGV             | 16   | 2500 | 330.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |
| LOG114AIRGVT | VQFN         | RGV             | 16   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 1.15    | 8.0     | 12.0   | Q2            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| LOG114AIRGVR | VQFN         | RGV             | 16   | 2500 | 356.0       | 356.0      | 35.0        |
| LOG114AIRGVT | VQFN         | RGV             | 16   | 250  | 210.0       | 185.0      | 35.0        |

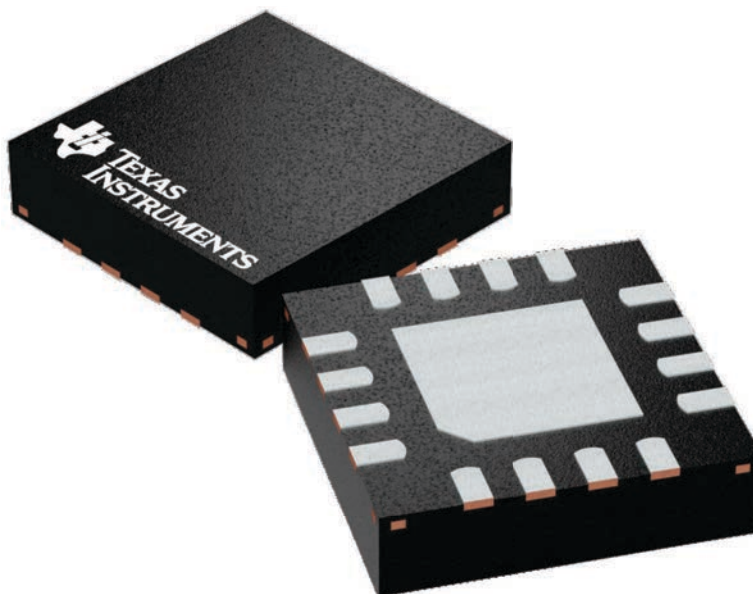
## GENERIC PACKAGE VIEW

**RGV 16**

**VQFN - 1 mm max height**

4 x 4, 0.65 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

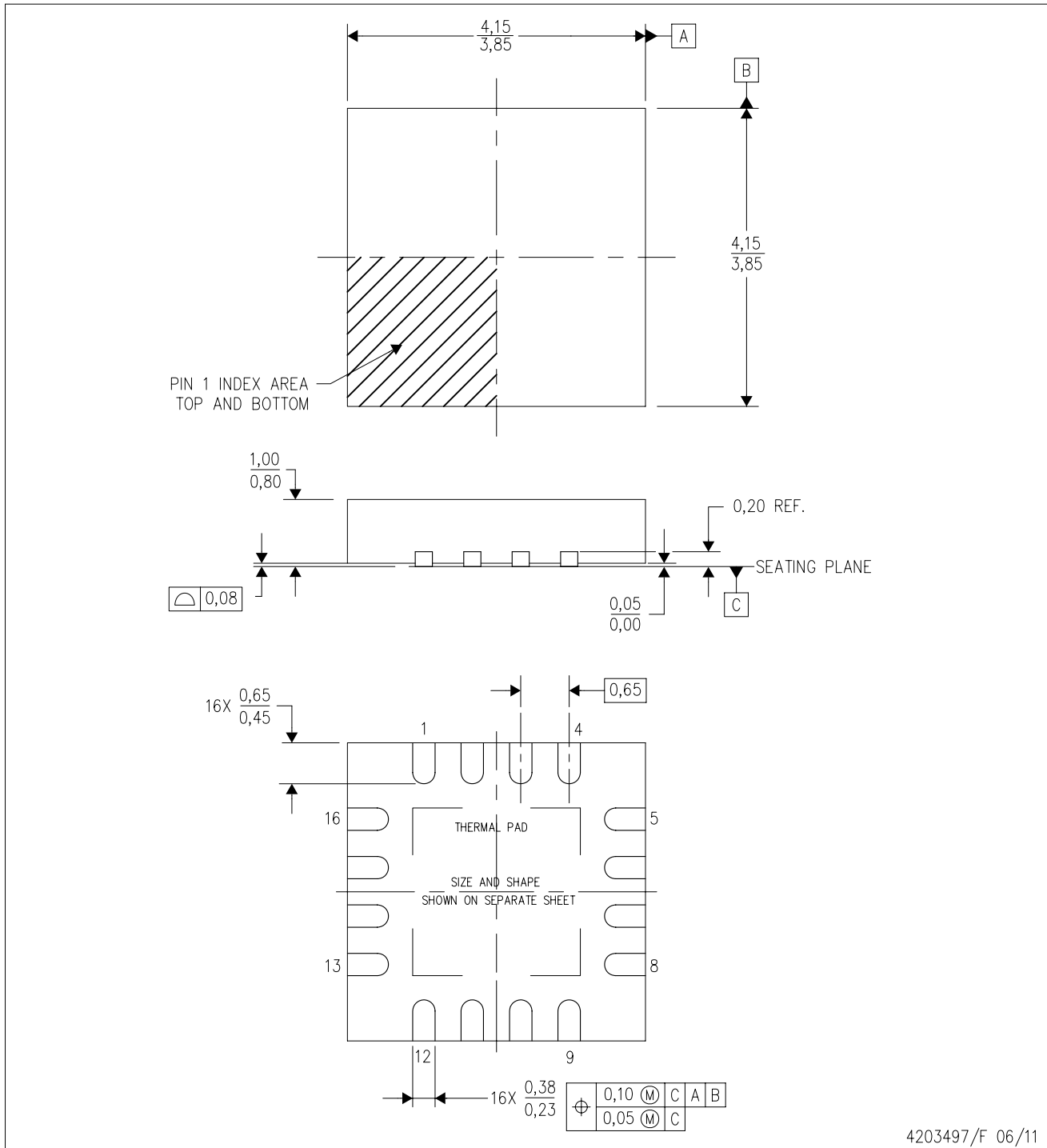


Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4224748/A

RGV (S-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - This drawing is subject to change without notice.
  - Quad Flatpack, No-leads (QFN) package configuration.
  - The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
  - Falls within JEDEC MO-220.

RGV (S-PVQFN-N16)

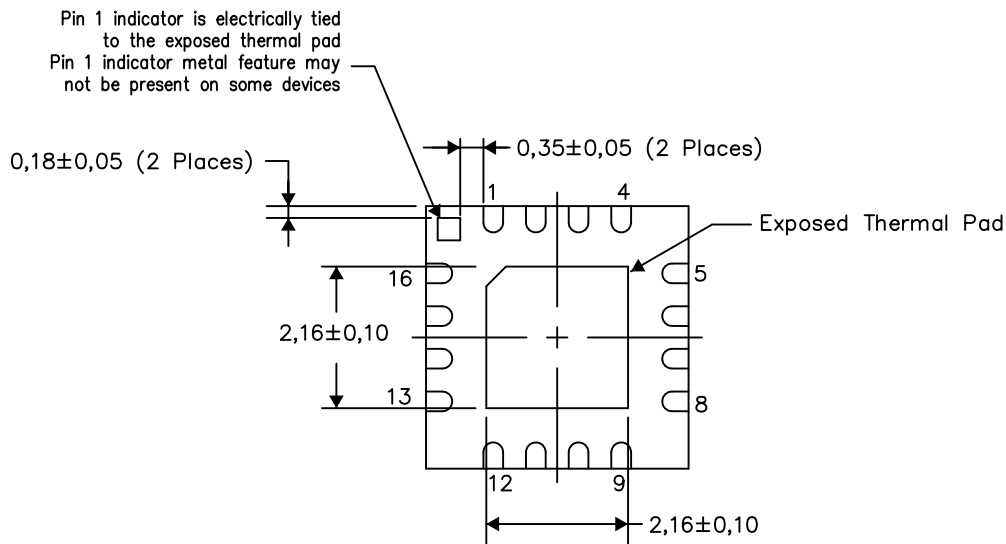
PLASTIC QUAD FLATPACK NO-LEAD

## THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

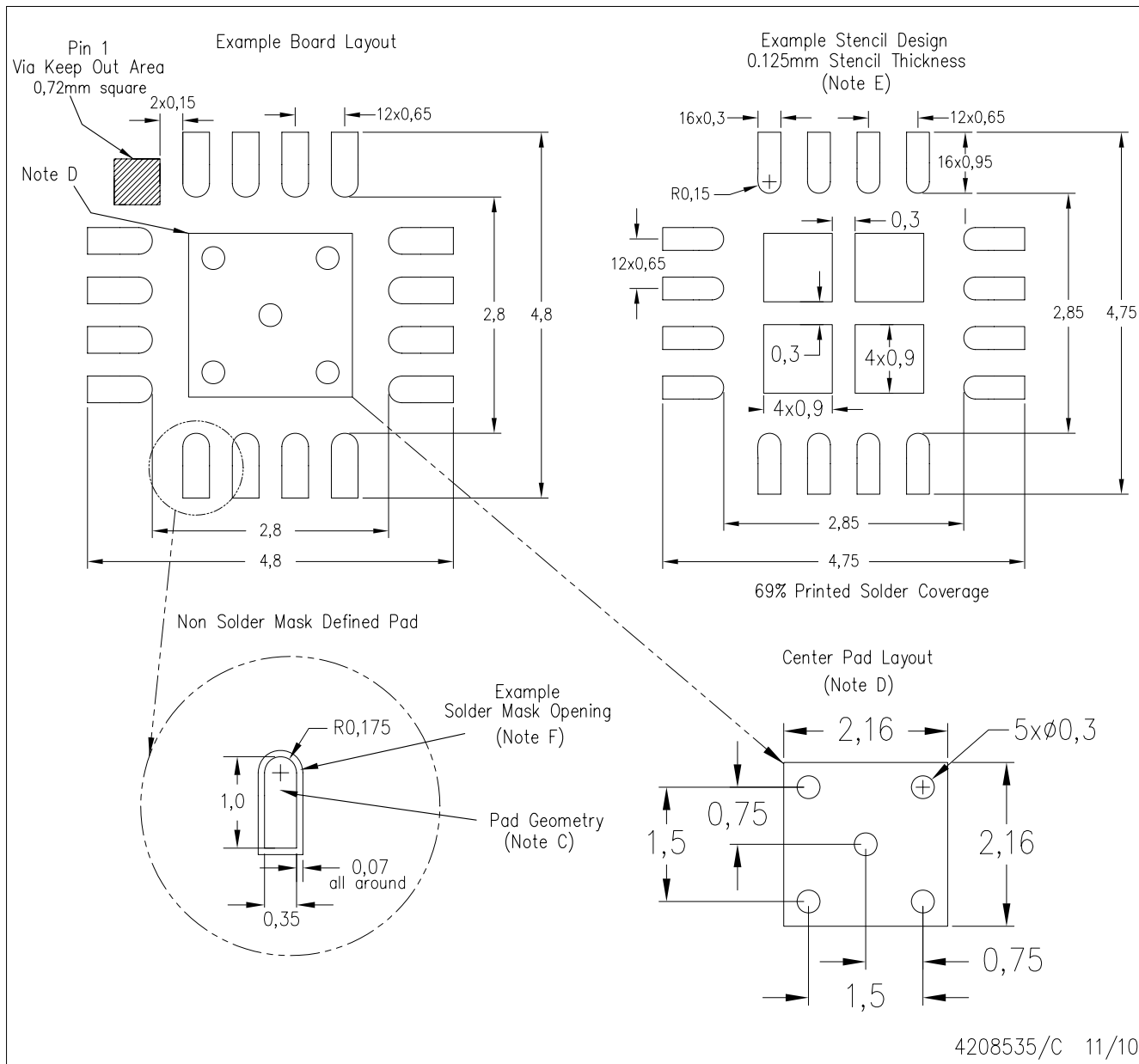
Exposed Thermal Pad Dimensions

4206351-2/L 05/13

NOTE: All linear dimensions are in millimeters

RGV (S-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



4208535/C 11/10

- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - F. Customers should contact their board fabrication site for solder mask tolerances.

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